

# **VB6955CM**

# 5.0 megapixel auto-focus camera module

#### **Datasheet - production data**



# Description

The VB6955CM is a high performance 5.0 megapixel auto-focus camera module. It is designed for use across a range of mobile phone handsets and accessories. The sensor supports high quality still camera functions as well as video modes.

The VB6955CM is compliant with the MIPI CSI-2 specification. It is capable of generating 10-bit raw Bayer 5.0 megapixel images up to 30 fps with two CSI-2 lanes. The VB6955CM offers an ultra low power consumption hardware standby mode.

Table 1.

Order code	Package	Packing		
VB6955CMQ0GH/1	SMIA75	Tape and reel		

### Features

- 5.0 megapixel resolution sensor (2600 x 1952) inclusive of 4 border pixels each sides
- integrated auto-focus mechanism
- compact size 7.5 mm x 7.5 mm x 4.6 mm
- MIPI CSI-2<sup>(a)</sup> dual lane interface (up to 840 Mbps per lane)
- CCI command interface, supports up to 400 kHz
- 2.8V analog and 1.8V digital operation
- supports 2 x 2 and 4 x 4 pixel binning
- integrated 8-Kbit OTP memory
- ultra low power standby mode
- on-chip couplet correction
- Flex compatible

This is information on a product in full production.

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## 1 Overview

The VB6955CM image sensor produces raw digital video data at up to 30 frames per second. The sensor supports horizontal flip and vertical mirroring. Output frequency can be derated as defined in the specification for power saving. Higher frame rate can be achieved through analog binning and subsampling modes.

The image data is digitized using an internal 10-bit column ADC. The resulting pixel data is output together with checksums and embedded codes for synchronization. The interface conforms to MIPI CSI-2 interface standards.

The sensor is fully configurable through a CCI serial interface. Both the CSI-2 and CCI interfaces are specified in a separate document: *MIPI alliance standard for camera serial interface 2 (CSI-2)*.

Feature	Detail
Pixel resolution	2600x 1952 with border pixels
Sensor technology	ST IMG140 FSI Gen2 based CMOS imaging process
Pixel size	1.4 μm x 1.4 μm
Analog gain	+ 24 dB
Digital gain	+ 6 dB
Dynamic range	60 dB
Signal to noise	36 dB (@ 100 lux)
Supply voltages	Analog: 2.6 to 2.9V Digital: 1.7 to 1.9 V VBAT: 2.5 to 4.8V
Typical power consumption 30 fps	130 mA (typical)
Operating temperature	-30°C to +70°C
Storage temperature	-40°C to +85°C
Average dark current (60C)	25 e/s
Shading (60C)	12 e/s

#### Table 2. Technical specification



# 1.1 VB6955CM use in system with software image processing

The VB6955CM image sensor can be directly connected to a baseband or multimedia processor. The image processing is done in software or hardware within the baseband processor.



Figure 1. VB6955CM in system with software image processing

# 1.2 Reference documents

#### Table 3. Reference documents

Title	Date
MIPI Alliance Standard for Camera Serial Interface 2 (CSI-2) v1.0	29/11/2005
MIPI Alliance D-PHY Specification (v1.00.00)	14/05/2009



# 2 Device pinout

*Figure 2* shows the position of the pins on the module and *Table 4* provides the signal descriptions.



Figure 2. VB6955CM module pinout (viewed from bottom of camera module)

Table 4. Pin description

Pad number	Pad name	Description			
Power supplies	Power supplies				
3	VBAT	VCM power			
7, 11	DGND, AGND	Digital and analog ground			
8	VANA	Analog power			
14	VCM_GND	VCM ground			
1	VDIG	Digital power			
System					
6	FSTROBE	Flash strobe			
5	EXTCLK	System clock input			
Control					
4	SCL	Serial communication clock			
2	SDA	Serial communication data			



Pad number	Pad name	Description
Data		
12	CLK- <sup>(1)</sup>	Output qualifying clock
13	CLK+ <sup>(1)</sup>	Output qualifying clock
9	DATA1- <sup>(1)</sup>	Serial output data
10	DATA1+ <sup>(1)</sup>	Serial output data
15	DATA2- <sup>(1)</sup> / CCP DATA+	Serial output data
16	DATA2+ <sup>(1)</sup> / CCP DATA-	Serial output data
ST test		
T1	ST test pin	Do not connect <sup>(2)</sup>

#### Table 4. Pin description (continued)

1. By default, the polarity of the CSI-2 data lanes and clock lanes are swapped. It is necessary to swap them by writing 0x02 to the registers 0x6006, 0x6007 and 0x6008. It is not possible to swap the CCP data lanes.

2. Test pin is not floating.



# 3 Functional description

### 3.1 External clock

### 3.1.1 Clock input type

The external clock provided by the host to the VB6955CM must be a DC coupled square wave and may also be RC-filtered.





### 3.1.2 PLL and clock input

The VB6955CM has an embedded PLL block. This block generates all necessary internal clocks from an input range defined in *Table 5*.

Table 5. Sy	ystem inp	out clock fr	requency	range
-------------	-----------	--------------	----------	-------

Minimum (MHz)	Maximum (MHz)
6	27

The value of the external clock frequency must be written to the register 0x0136 (extclk\_frequency\_mhz).



# 3.2 Device operating modes

The mode changes in VB6955CM are shown in *Figure 4*. Further details are provided in *Section 3.2.1* to *Section 3.2.8*.





### 3.2.1 Power-up procedure

To start the sensor, VDIG, VANA should be set high and EXTCLK started. These can be powered up in any order and have no time constraints. After all three signals are working, the software standby state is reached, the OTP data is read internally<sup>(b)</sup> and CCI activity can begin.

On power-up the on-chip power-on reset cell ensures that the CCI register values are initialized correctly to their default values.

The power-up sequence timing constraints are shown in Table 6.

Symbol	Parameter	Minimum	Maximum	Units
tO	VANA rising – VDIG rising	VBAT, VANA and	/DIG may rise in	ns
t1	VDIG rising – VANA rising	any order. The ri can vary from 0	sing separation ns to indefinite.	ms
t4	EXTCLK – first CCI transaction with gated clock	5	-	ms
t5	PLL start up/lock time	-	1	ms
t6	Entering streaming mode – First frame start sequence (fixed part)	-	10	ms
t7	Entering streaming mode – First frame start sequence (variable part) = Integration time	fine_integration_ time_min	-	ms

 Table 6. Power-up sequence timing constraints

b. The OTP is read once coming out from hardware standby and VANA powers the OTP.





#### Figure 5. VB6955CM power-up sequence for CCP2 mode





#### Figure 6. VB6955CM power-up sequence for CSI-2 mode



### 3.2.2 Power-down procedure

The power-down sequence timing constraints are shown in Table 7.

Symbol	Parameter	Minimum	Maximum	Units
t8	Last CCI transaction to MIPI frame end <sup>(1)</sup>	-	1 frame	
t9	Minimum EXTCLK cycles required after last CCI transaction or MIPI frame end <sup>(2)</sup>	512	-	clock cycles
t11	VBAT, VANA, VDIG falling	VBAT, VANA and any order, the fa can vary from 0		

Table 7. Power-down sequence timing constraints for CSI2 communications

 The whole power-down sequence is triggered by the CCI power-down request, however the power-down sequence only starts after the end of the frame when all active data is consumed on CSI-2 DN/DP pins. Once this is done, the CSI-2 DN/DP signals enter LP11 and the system enters software standby. The CSI-2 clock enters LP11 with a delay of 5 us (corresponding to Tclk\_post + Tclk\_trail) compared to DN/DP pins.

2. After the last frame completion, the gated clock needs to be kept for at least 512 cycles so the system can enter LP11 Low Power mode. After the system enters LP11 mode, you can keep or stop the EXTCLK.





Figure 7. VB6955CM power-down sequence for CSI-2 mode



### 3.2.3 Internal power-on reset (POR)

The VB6955CM internally performs a power-on reset (POR) when the 1V2 VDD digital supply rises through the trigger level, Vtrig\_rising. Similarly, if the 1V2 VDD digital power supply falls through the trigger level, Vtrig\_falling, then the power-on reset also triggers.

#### Definitions

Rise threshold voltage (VTRIGR)	This is the supply voltage level that is recognized by the POR as voltage "HIGH". Only after the supply reaches this level does the output of POR change to high level if it is off, after a specified amount of delay.
Fall threshold voltage (VTRIGF)	This is the supply voltage level that is recognized by the POR as voltage "LOW". Only after the supply reaches this level does the output of POR change to low (ground) level if it is on.
Burst width (pw)	Burst is the negative pulse riding the supply signal. The burst width is measured as the amount of duration for which the supply signal dropped beyond the threshold levels.
Delay duration (TPOR)	Delay duration is defined as the time duration for which POR stays off before re-powering. Each reset of POR imparts a specified delay duration before POR re- powers.







Symbol	Constraint	Minimum	Typical	Maximum	Units
VTRIGR	POR rise voltage detection			0.95	V
VTRIGF	POR fall voltage detection	0.4			V
Tburst (pw)	Burst filter		2	8	μs
Tpor	Delay duration		20	45	μs

Table 8. POR cell characteristics

#### 3.2.4 Power off

The power off state is defined as either or both of the digital and analog supplies not present.

#### 3.2.5 Hardware standby

This is the lowest power consumption mode. CCI communications are not supported in this mode. The PLL and the video blocks are powered down. This state is entered by stopping the external clock. All registers are returned to their default values

### 3.2.6 Software standby

Software standby mode preserves the contents of the CCI register map. CCI communications are supported in this mode. The software standby mode is selected using a serial interface command. If this state is entered from hardware standby, the data pads remain at LP-00. If this state is entered from streaming then the data pads go to LP-11 at the end of the current frame. The internal video timing is reset to the start of a video frame in preparation for the enabling of active video. The values of the serial interface registers such as exposure and gain are preserved. The system clock must remain active when communicating with the sensor.

This state is entered by releasing the device from hard reset by writing 0x00 to the mode control register (0x0100) or commanding a soft reset by writing 0x01 to the software reset register (0x0103).

Note: After a soft reset, all registers are returned to their default values.

#### 3.2.7 Streaming

The VB6955CM streams live video. This mode is entered by writing 0x01 to the mode control register (0x0100).



### 3.2.8 Fast standby mode

The fast software standby mode can be controlled using register 0x0106. By default it is disabled.

If this mode is disabled (that is, standard mode is enabled) and the software standby command is issued while streaming, the transmission of the current frame completes before the VB6955CM enters software standby.

If fast software standby mode is enabled, there are three possibilities for where the VB6955CM may be in the frame that is being read out when the command to go to software standby is received:

• command received during frame blanking

There is no difference in this situation if fast standby mode is enabled or disabled. The VB6955CM immediately enters software standby.

• command received during the active line

In CCP2 mode, the VB6955CM outputs the current line including the line end code and then terminates the frame by transmitting a line start code and a frame end code. The VB6955CM then immediately enters software standby mode.

In CSI-2 mode, the VB6955CM outputs the current packet and terminates the frame with a frame end packet. The VB6955CM then immediately enters software standby mode.

• command received during the line blanking

In CCP2 mode, the VB6955CM terminates the frame by transmitting a line start code and a frame end code. The VB6955CM then immediately enters software standby mode.

In CSI-2 mode, as the VB6955CM is already in an LP idle state, the VB6955CM immediately enters software standby mode.



# 4 Camera control interface (CCI)

This chapter specifies the camera control interface (CCI). The I<sup>2</sup>C-type interface uses 1.8 V I/O with two signals: serial data line (SDA) and serial clock line (SCL). CCI is used for control data transfer. Clock signal (SCL) generation is performed by the master device (the camera module is a slave device). The master device initiates data transfer. The CCI bus on the camera module has a maximum speed of 400 Kbits/s and has a software switchable device address. The default device address is 0x20.

Any internal register that can be written to, can also be read from. There are also read only registers that contain device status information, for example, design revision details. A read instruction from an unused register location returns the value 0x00. A read instruction from a reserved address may return any value. A write instruction to a reserved or unused register location is illegal and the effect of such a write is undefined. It is the responsibility of the host system to only write to register locations which have been defined.

### 4.1 Valid register data types

The contents of the registers can represent a number of different data types (see *Table 9*). The register map uses this coding to help with the interpretation of the contents of each register.

Data type	Name	Range	Description
8UI	8-bit unsigned integer	0 to 255	-
8SI	8-bit signed integer	-128 to 127	Two's complement notation
16UI	16-bit unsigned integer	0 to 65535	-
16SI	16-bit signed integer	-32768 to 32767	Two's complement notation
16UR	16-bit unsigned iReal	0 to 255.99609375	08.08 fixed point number. 8 integer bits (MS Byte), 8 fractional bits (LS Byte)
16SR	16-bit signed iReal	-128 to 127.9960375	Two's complement notation, 8 fractional bits
32UR	32-bit unsigned iReal	0 to 65535.99998474	16.16 fixed point number. 16 integer bits (MS 2 Bytes), 16 fractional bits (LS 2 Bytes)
32SF	32-bit IEEE floating- point number	As per IEEE 754	As per IEEE 754. 1 sign bit, 8 exponent bits, 23 fractional bits
8C or 16C	8-bit or 16-bit coded	-	This indicates that the value is decoded to select one of several functions or modes.
8B or 16B	8 or 16 bits	-b	Each bit represents a specific function or mode.

#### Table 9. Valid register data types



# 4.2 Register map

The registers default values are expressed as hexadecimal numbers.

### 4.2.1 Status registers [0x0000 to 0x001f]

Index	Byte	Register name	Data type	Default	Туре	Comment
0	Hi			07		1955
1	LO	module_model_id	16UI	a3	RO	Camera model identification number. Default values depend on NVM content.
2		revision_number_major	8UI	00	RO	Revision identifier of the camera for DCC change. Default value depends on NVM content.
3		manufacturer_id	8UI	01	RO	Module manufacturer number. Default value depends on NVM content.
4		smia_version	8UI	0a	RO	SMIA version that sensor complies with 10 - Version 1.0
5		frame_count	8UI	ff	RW	Frame count register. Increments from 1 to 254 when streaming. Reports 255 when idle.
6		pixel_order	8UI	00	RO	Color pixel readout order. Changes with mirror and flip (register 0x0101). 0x00 - GR/BG normal. 0x01 - RG/GB horizontal mirror. 0x02 - BG/GR vertical flip. 0x03 - GB/RG vertical flip and horizontal mirror.
8	HI	data nedestal	16111	00	PO	Offset applied to the video data
9	LO	uala_pedesiai	1001	40	ŇŎ	Onset applied to the video data.
с		pixel_depth	8UI	0a	RO	Pixel depth resolution of the sensor.
10		revision_number_minor	8UI	00	RO	Revision identifier of the camera for minor changes. Default value depends on NVM content.
11		additional_spec_ver	8UI	08	RO	Additional specification identifier.
12	[3:0]	module_date_year	8UI	00	RO	Last digit of manufacturing year. Default value depends on NVM content.

### Table 10. Status registers [0x0000 to 0x001f]



Index	Byte	Register name	Data type	Default	Туре	Comment
13	[3:0]	module_date_month	8UI	00	RO	Manufacturing month. Default value depends on NVM content.
14	[4:0]	module_date_day	8UI	00	RO	Manufacturing day. Default value depends on NVM content.
15	[2:0]	module_date_phase	8UI	01	RO	Manufacturing phase identification. 0 = TS (Test Sample) 1 = ES (Engineering Sample) 2 = CS (Customer Sample) 3 = MP (Mass Production) Default value depends on NVM content.
16			03	03		Silicon identification number.
17		sensor_model_id	16UI	bb	RO	This may not be the same as the module identification number, for example, in the case where the sam silicon is used in two different modules.
18	[3:0]	sensor_nvm_revision_id	8UI	00	RO	Silicon NVM revision number. Default value depends on NVM content.
	[7:4]	sensor_mask_set_revision_id		01	RO	Silicon mask revision code.
19		sensor_manufacturer_id	8UI	01	RO	Silicon manufacturer number - ST Microelectronics.
1a		sensor_firmware_version	8UI	11	RO	Silicon firmware version with format "[7:4].[3:0]", for example 0x11 = "1.1".
1c	HI			00		Sequential number starting at 0 and
1d	3rd	serial number	32111	00	RO	incrementing by 1. Specification
1e	2nd		5201	00		Default value depends on NVM
1f	LO			00		content.

### Table 10. Status registers [0x0000 to 0x001f] (continued)



### 4.2.2 Frame format description registers [0x0040 to 0x0049]

For a full description of the frame format description refer to Section 5.1.

Index	Byte	Register name	Data type	Default	Туре	Comment
40		frame_format_model_type	8UI	01	RO	Generic frame format.
41		frame_format_model_ subtype	8UI	22	RO	Contains the number of 2-byte data format descriptors used. The upper nibble defines the number of column descriptors. The lower nibble defines the number of row descriptors.
42	н	frame_format_descriptor_0_	1611	5a	RO	number of visible columns.
43	LO	req	1001	28		
44	н	frama format descriptor 1	16111	20	PO	8 dummy columns.
45	LO		1001	08	ŇŬ	
46	н	fromo format deparintar 2	4.01.11	10	BO	2 omboddod rowo (SOE)
47	LO		1001	03	RU	S embedded fows (SOF).
48	ні	frame_format_descriptor_3_	1611	57	BO	number of visible rows
49	LO	req	1001	a0		number of visible rows

#### Table 11. Frame format description registers [0x0040 to 0x0049]

### 4.2.3 Analogue gain description registers [0x0080 to 0x0093]

For a full description of the analogue gain description registers refer to Section 6.6.1.

Index	Byte	Register name	Data type	Default	Туре	Comment	
80	HI	analogue gain canability	16111	00	RO	Analogue gain capability - single	
81	LO	analogue_gam_capability	1001	00	ŇŎ	global gain only.	
84	HI	analogue gain code min	16111	00	PO	Minimum recommended analogue	
85	LO		1001	00	ĸŬ	gain code.	
86	HI	analagua gain aada may	16UI	00	RO	Maximum recommended analogue gain code.	
87	LO	analogue_gain_code_max		fO			
88	ні	analogue gain code sten	16111	00		Analogue gain code step size.	
89	LO	analogue_gain_coue_step	1001	10	ŇŎ		
8a	HI		16111	00	PO		
8b	LO	analogue_gain_type	1001	00	ŇŎ	Analogue gain type.	
8c	HI	analoguo gain m0	16111	00	PO	Analogue gain constant MO	
8d	LO	analogue_galli_illo	1601	00	κυ	Analogue gain constant MU.	

### Table 12. Analogue gain description [0x0080 to 0x0093]



Index	Byte	Register name	Data type	Default	Туре	Comment
8e	HI	analogue gain c0	16UI	01	RO	Analogue gain constant C0.
8f	LO	analogue_gain_co		00		
90	н	analogua gain m1	4.01.11	ff	RO	Analogue gain constant M1.
91	LO	analogue_gain_ini	1001	ff		
92	н	analogua gain at	4.01.11	01	RO	Analogue gain constant C1.
93	LO	analogue_gain_cr	1001	00		

Table 12. Analogue gain description [0x0080 to 0x0093] (continued)

# 4.2.4 Data format description registers [0x00c0 to 0x00c9]

Index	Byte	Register name	Data type	Default	Туре	Comment
c0		data_format_model_type	8UI	01	RO	2-byte generic data format model type
c1		data_format_model_ subtype	8UI	04	RO	Number of data format descriptors.
c2	HI	-data_format_descriptor_0	16UI	08	RO	RAW8 mode - transmit top 8 bits of pixel data.
c3	LO			08	Ň	
c4	HI	data format depariator 1	16UI	0a	PO	RAW10 mode - transmit top 10 bits of pixel data.
c5	LO			0a	ŇŎ	
c6	HI		4.01.11	0a	50	10-8 compressed mode - transmit top 10 bits of pixel data, compressed to 8 bits.
c7	LO	data_format_descriptor_2	1601	08	RO	
c8	HI		4.01.11	0a		10-6 compressed mode - transmit
c9	LO	data_tormat_descriptor_3	16UI	06	RO	top 10 bits of pixel data, compressed to 6 bits.



## 4.2.5 Setup registers [0x0100 to 0x0137]

Index	Byte	Register name	Data type	Default	Туре	Comment
100		mode_select	8UI	00	RW	Mode select. 0 = Software standby. 1 = Streaming.
101	[0]	x_rev_req	0111	00	RW	Image orientation in X. 0 = Normal 1 = X-mirror mode.
	[1]	y_rev_req		00	RW	Image orientation in Y. 0 = Normal 1 = Y-flip mode.
103		soft_reset	8UI	00	RW	Software reset returns the sensor to its power-on defaults. 0 = Normal operation. 1 = Software reset enabled.
104		inhibit_retime	8UI	00	RW	The grouped parameter hold register disables the consumption of integration, gain and video timing parameters. 0 = Consume values as normal. 1 = Do not consume values whilst set high.
105		mask_corrupt	8UI	00	RW	Setting this register to 1 prevents the sensor out-putting frames that have been corrupted by video timing parameter changes. 0 = Output as normal. 1 = Mask corrupted frames.
107		cci_addr	8UI	20	RW	Device address.
108	[0]	second_i2c_if_en	0111	00	RW	Second I <sup>2</sup> C interface enable. 0 = Disabled 1 = Enabled
100	[1]	second_i2c_if_ack_en		00	RW	Second I <sup>2</sup> C interface ACK enable. 0 = Disabled 1 = Enabled
109		cci_2nd_addr	8UI	20	RW	Additional device address that can be responded to.
110		csi_channel_identifier	8UI	00	RW	The DMA (CCP2) or virtual (CSI2) channel identifier. Valid range = 0 to 7 for CCP2. Valid range = 0 to 3 for CSI2.

### Table 14. Setup registers [0x0100 to 0x0137]



Index	Byte	Register name	Data type	Default	Туре	Comment
111		csi_signalling_mode	8UI	02	RW	Determines which transmission signalling mode is to be used. 0 = CCP2 data-clock signaling. 1 = CCP2 data-strobe signaling. 2 = CSI2.
112	ні	- csi_data_format	16UI	0a	PW/	The value of this register contains the pixel width of the uncompressed pixel data. Valid values are 0xA and 0x8.
113	LO			0a		The value of this register contains the pixel width of the compressed pixel data. Valid values are 0xA and 0x8.
114		csi_lane_mode	8UI	01	RW	Number of data lanes in use. 0 = 1-lane. 1 = 2-lane.
115		csi2_10_to_8_dt	8UI	30	RW	CSI-2 data type for 10-to-8 compression.
117		csi2_10_to_6_dt	8UI	31	RW	CSI-2 data type for 10-to-6 compression.
120		gain_mode	8UI	00	RO	Global gain mode - this device only supports 0x00.
130	HI	vana voltade	16UR	02	RW/	Typical supplied VANA voltage
131	LO	vana_vonage	1001	СС		Typical supplied VAINA Voltage.
132	н		16UR	01	RW/	Typical supplied VDIG voltage
133	LO	volg_voltage	TOOK	сс		rypical supplied volice voliage.
134	н	vio voltage	16UR	01	RW/	Typical IO voltage
135	LO	vio_voltage	1001	сс	1	
136	н	ext clkfreg	16UR	06	RW	8.8 fixed-point representation of the
137	LO		1001	00		external clock-frequency, in MHz.

### Table 14. Setup registers [0x0100 to 0x0137] (continued)



### 4.2.6 Integration and gain registers [0x0200 to 0x0215]

These registers are used to control the image exposure. See *Section 6.6* for more information.

Index	Byte	Register name	Data type	Default	Туре	Comment
200	HI	fine evo rea	16111	02	RW/	Fine integration time in nivels
201	LO	line_exp_req	1001	ae	1	n me integration time in pixels.
202	HI		16111	00		Coarso integration time in lines
203	LO	coarse_exp_req	1001	00		Coarse integration time in lines.
204		gain_req_dummy_hi	8UI	00	RO	Dummy HI byte to ensure presence in SLC test
205		gain_req	8UI	00	RW	Gain code for all channels.
20e	HI	disitet asia ana an		01	D\//	Green (red row) channel digital gain value
20f	LO	ugitai_gain_greent	TOUR	00		
210	HI	digital gain rad		01		Red channel digital gain value
211	LO	loigitai_gain_reo	16UR	00	RVV	
212	HI	digital gain blue		01		Plue channel digital gain value
213	LO	ugitai_gain_blue	TOUR	00	RVV	biue channel digital gain value
214	HI	digital gain groonP	161 ID	01		Green (blue row) channel digital gain
215	LO	uyitai_yaiii_yieeiib	160R	00		value.

#### Table 15. Integration and gain registers [0x0200 to 0x0215]

### 4.2.7 Video timing registers [0x0300 to 0x0387]

For a full description of the video timing registers refer to *Chapter 5*.

Index	Byte	Register name	Data type	Default	Туре	Comment
300		vt_pix_clk_div_dummy_hi	8UI	00	RO	Dummy HI byte to ensure presence in SLC.
301		vt_pix_clk_div	8UI	0a	RW	Video timing pixel clock divider.
302		vt_sys_clk_div_dummy_hi	8UI	00	RO	Dummy HI byte to ensure presence in SLC.
303		vt_sys_clk_div	8UI	01	RW	Video timing system clock divider.
304		pre_pll_div_dummy_hi	8UI	00	RO	Dummy HI byte to ensure presence in SLC.
305		pre_pll_div	8UI	01	RW	Pre-PLL clock divider value. 1 = Divide EXTCLK by 1. 2 = Divide EXTCLK by 2. 4 = Divide EXTCLK by 4.

### Table 16. Video timing registers [0x0300 to 0x0387]



Index	Byte	Register name	Data type	Default	Туре	Comment
306		pll_mult_dummy_hi	8UI	00	RO	Dummy HI byte to ensure presence in SLC.
307		pll_mult	8UI	85	RW	PLL multiplier value. Odd and even values can be used, but odd values result in the nearest lower even value being used (for example, 133 becomes 132).
308		op_pix_clk_div_dummy_hi	8UI	00	RO	Dummy HI byte to ensure presence in SLC.
309		op_pix_clk_div	8UI	0a	RW	Output timing pixel clock divider.
30a		op_sys_clk_div_dummy_hi	8UI	00	RO	Dummy HI byte to ensure presence in SLC.
30b		op_sys_clk_div	8UI	01	RW	Output timing system clock divider.
340	н	frame_length_req 16	1611	08	RW	Length of the video frame in lines
341	LO		1001	24		
342	HI	line length reg	16UI	0a	RW	Length of a line of video in pixels
343	LO			be		
344	HI	-x_start_req	16UI	00	RW	X pixel address of the top left corner
345	LO			00		of the visible pixel data.
346	HI	v start reg	16UI	00	- RW	Y line address of the top left corner of the visible pixel data.
347	LO			00		
348	HI	x_end_req	16UI	0a	RW	X pixel address of the bottom right
349	LO			27		corner of the visible pixel data.
34a	HI	y_end_req	16UI	07	RW	Y line address of bottom right corner
34b	LO			9f		of the visible pixel data.
34c	HI	x_op_size_req	16UI	0a	RW	Width in pixels of the output image
34d	LO			28		
34e	HI	y_op_size_req	16UI	07	RW	Height in lines of the output image
34f	LO			a0		
380		x_even_inc_req_dummy_hi	8UI	00	RO	Dummy HI byte to ensure presence in SLC Test
381		x_even_inc_req	8UI	01	RW	X address increment for even pixels.
382		x_odd_inc_req_dummy_hi	8UI	00	RO	Dummy HI byte to ensure presence in SLC test
383		x_odd_inc_req	8UI	01	RW	X address increment for odd pixels.
384		y_even_inc_req_dummy_hi	8UI	00	RO	Dummy HI byte to ensure presence in SLC test

Table 16	Vidoo timin	a rogistore	[0v0200 to	0-02971	(continued)
Table 16.	. video timin	g registers	<b>LOXO300 tO</b>	UXU387](	(continuea)



		-	_	-		
Index	Byte	Register name	Data type	Default	Туре	Comment
385		y_even_inc_req	8UI	01	RW	Y address increment for even lines.
386		y_odd_inc_req_dummy_hi	8UI	00	RO	Dummy HI byte to ensure presence in SLC test
387		y_odd_inc_req	8UI	01	RW	Y address increment for odd lines.

#### Table 16. Video timing registers [0x0300 to 0x0387] (continued)

## 4.2.8 Scaler and digital crop registers [0x0400 to 0x040f]

Table 17. Scaler and	digital crop registers	[0x0400 to 0x040f]
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Index	Byte	Register name	Data type	Default	Туре	Comment
400		scale_mode_req_dummy_hi	8UI	00	RO	
401		scale_mode_req	8UI	00	RW	Scaling mode 0 = No scaling 1 = Horizontal scaling
402		scale_cosite_req_dummy_ hi	8UI	00	RO	
403		scale_cosite_req	8UI	00	RW	Spatial sampling 0 = Bayer sampling 1 = Co-sited (2- or 4-component) 2 = Co-sited (3-component)
404		scale_m_req_dummy_hi	8UI	00	RO	
405		scale_m_req	8UI	10	RW	Down scale factor. M component.
406	HI		16111	00	RO	Down scale factor. N component.
407	LO	Scale_11	1001	10	ŇŎ	
408	HI			00		Offset from X-address of the top left corner of the visible pixel data after analog crop, bin and subsample. Even numbers only (pixels).
409	LO	digital_crop_x_offset	16UI	00	RW	
40a	HI			00		Offset from Y-address of the top left
40b	LO	digital_crop_y_offset	16UI	00	RW	corner of the visible pixel data after analog crop, bin and subsample. Even numbers only (lines).
40c	HI	digital area image width	16111	0a		Image width after digital crop. Even
40d	LO	uigitai_crop_image_width	1001	28		numbers only (pixels).
40e	HI	digital crop image beight	16111	07	D\//	Image height after digital crop. Even
40f	LO	ugitai_crop_image_neignt	1001	a0	κw	numbers only (lines).



### 4.2.9 Compression setup registers [0x0500 to 0x0501]

Index	Byte	Register name	Data type	Default	Туре	Comment
500 501		compression_algorithm	16UI	00 01	RO	Compression algorithm is DPCM/PCM.

#### Table 18. Compression setup registers [0x0500 to 0x0501]

## 4.2.10 Test pattern registers [0x0600 to 0x0611]

Index	Byte	Register name	Data type	Default	Туре	Comment
600		man_spec_patt_req	8UI	00	RW	Enables maufacturer-specific test patterns. 0 = Enable SMIA test patterns. 1 = Enable manufacturer-specific test patterns.
601		test_pattern_req	8UI	00	RW	SMIA test pattern selector. Note that the PN9 test pattern replaces data at output TX stage. bit0 = No pattern bit1 = Solid color bit2 = 100% color bars bit3 = Fade-to-grey color bars bit4 = Pseudo random-PN9
602	ні	test data red	16UI	00	RW	Test data used to replace Red pixel
603	LO			00		data - range 0 to 1023.
604	HI		16UI	00	RW	Test data used to replace Green pixel data on lines that also have Red pixels - range 0 to 1023.
605	LO	test_data_greenr		00		
606	HI	test data blue	16UI	00	R\\/	Test data used to replace Blue pixel data - range 0 to 1023.
607	LO			00	1	
608	HI			00	514	Test data used to replace Green pixel data on lines that also have Blue pixels - range 0 to 1023.
609	LO	test_data_greenb	1601	00	RW	
60a	HI	toot hour width	16111	00		Defines the width in pixels of the
60b	LO		1001	00	RVV	horizontal cursor.
60c	HI	test hour posp	1611	00	D\\/	Defines the position of the top edge
60d	LO	- test_ncur_posn	1001	00		of the horizontal cursor.
60e	HI	test your width	161.11	00	D\\/	Defines the width in pixels of the
60f	LO		1601	00		vertical cursor.

 Table 19. Test pattern registers [0x0600 to 0x0611]



Index	Byte	Register name	Data type	Default	Туре	Comment
610	HI			00	-	Defines the left hand edge of the vertical cursor
611	LO	test_vcur_posn	16UI	00	RW	The value can be set to 0xFFFF which enables an automatic mode whereby the cursor advances every frame. Can be used to visually check the frame count.

#### Table 19. Test pattern registers [0x0600 to 0x0611] (continued)

### 4.2.11 CSI2 registers [0x808]

#### Table 20. CSI2 registers [0x808]

Index	Byte	Register name	Data type	Default	Туре	Comment
808		dphy_ctrl	8UI	00	RW	CSI2 DPHY control 1 = Use UI control. 2 = Use register control.

# 4.2.12 DPHY registers [0x820 to 0x823]

Table 21.	DPHY	registers	[0x820	to 0x823]
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Index	Byte	Register name	Data type	Default	Туре	Comment
820	HI					CSI2 DPHY requested (target)
821	3rd					channel rate in Mbps (16.16 fixed- point representation)
822	2nd					This is used to calculate the DPHY unit-interval (UI) value.
823	LO	dphy_channel_mbps_for_ui	32UR	00.00	RW	It does not control the sensor clock setup, but should normally correspond to those settings.
						0 = Sensor automatically calculates UI from host-programmed EXTCLK and clock divider values and reports in MAN_SPEC_DPHY_CLKLANE_ UIX4 register. 80-800 = Sensor calculates UI from Mbps value.

### 4.2.13 Binning registers [0x900 to 0x902]

Index	Byte	Register name	Data type	Default	Туре	Comment
900		binning_mode	8UI	00	RW	Binning mode. 0 = Disabled 1 = Enabled
901		binning_type	8UI	00	RW	High-nibble = Column binning factor. High-nibble = Row binning factor.
902		binning_weighting	8UI	00	RW	Binning weighting type: 0 = Averaged.

Table 22. Binning registers [0x900 to 0x902]

### 4.2.14 Data transfer registers [0x0a00 to 0x0a43]

Index	Byte	Register name	Data type	Default	Туре	Comment
a00		data_xfer_if1_ctrl	8UI	00	RW	bit0: 0 = Disable Xfer IF1. 1 = Enable Xfer IF1. bit1: 0 = Read enable on IF1 1 = Write enable on IF1 bit2: 0 = Disabled 1 = Clear error bits on IF1
a01		data_xfer_if1_status	8UI	00	RO	bit0: Read IF ready bit1: Write IF ready. bit2: Data corrupt. bit3: Improper IF usage.
a02		data_xfer_if1_page_select	8UI	00	RW	Select RW Pages from 0 to 255 for IF1.
a04		DataXfer_Data0	8UI	00	RW	Data Xfer Interface - DataLoc0
a43		DataXfer_Data63	8UI	00	RW	Data Xfer Interface - DataLoc63

#### Table 23. Data transfer registers [0x0a00 to 0x0a43]



### 4.2.15 Ideal raw registers [0x0b04 to 0x0b05]

Index	Byte	Register name	Data type	Default	Туре	Comment
b04		black_level_correction_ enable	8UI	01	RW	Black level correction. 0 = Disabled 1 = Enabled
b05		mapped_couplet_correct_ enable	8UI	01	RW	Mapped couplet correction enable. 0 = Disabled 1 = Enabled

 Table 24. Ideal raw registers [0x0b04 to 0x0b05]

### 4.2.16 Flash registers [0x0c12 to 0x0c2a]

Index	Byte	Register name	Data type	Default	Туре	Comment
c12		flash_strobe_adjustment	8UI	00	RW	Register to control pre-divider for flash_strobe_width counter.
c14	HI	flash_strobe_start_point	4.01.11	00		Register to select reference point for
c15	LO		1601	00	RVV	steps. Range 0 - last line.
c16	HI	tFlash_strobe_delay_rs_ ctrl	1611	00		1H stop 0-65535
c17	LO		1001	00	17.00	Паер. 0-00000.
c18	н	tFlash_strobe_width_high_	1611	00		Used to control flash strobe width in
c19	LO	rs_ctrl	1001	00	17.00	rolling shutter mode. 1-65535.
c1a		Flash_mode_rs	8UI	00	RW	Bit[0] - Flash mode (rolling shutter): 0 = strobe usage in single trigger mode. 1 = strobe usage in continuous mode.
c1b		Flash_trigger_rs	8UI	00	RW	Bit[0] - Flash trigger (rolling shutter): 0 = disable strobe generation. 1 = trigger flash (auto clear in single mode).
c1c		Flash_status	8UI	00	RO	<ul> <li>Bit[0] - Flash status:</li> <li>0 = flash strobe is not retimed to this frame.</li> <li>1 = flash strobe is retimed to this frame.</li> <li>Bit[1]:</li> <li>0 = flash is not active in global reset.</li> <li>1 = flash is active in global reset mode.</li> </ul>

### Table 25. Flash registers [0x0c12 to 0x0c2a]


Index	Byte	Register name	Data type	Default	Туре	Comment					
c26	HI	tFlash_strobe_width_	1611	00		Used to control flash strobe width in					
c27	LO	high_rs_ctrl	1001	00	1	rolling shutter mode. 1-65535.					
c28	н	tFlash_strobe_width_low_	16UI	00		Used to control flash strobe width in rolling shutter mode. 1-65535.					
c29	LO	rs_ctrl		00							
c2a		tFlash_strobe_count_rs_ ctrl	8UI	00	RW	Used to control flash strobe width in rolling shutter mode. 1-255.					

Table 25. Flash registers [0x0c12 to 0x0c2a] (continued)

# 4.2.17 Sensor - high level auto focus registers [0x0d80 to 0x0d89]

Index	Byte	Register name	Data type	Default	Туре	Comment	
d80	HI	FOCUS CHANGE	16111	00	RW/	This register is used to change the	
d81	LO		1001	00		focus point.	
d82	HI	FOCUS CHANGE CONTR		00		Bit[0] - fcc_enable	
d83	LO	OL	1601	00	RW	Bit[9] - Automatic ringing compensation enable	
d84	HI			00		Specifies the increased or decreased	
d85	LO	FOCUS_CHANGE_NUMBE R_ PHASE1	16UI	00	RW	value from focus change register and specifies the amount of focus change at each strobe. Applicable for phase 1 sequence.	
d86	HI			00		Specifies the increased or decreased	
d87	LO	R_ PHASE2	16UI	00	RW	specifies the amount of focus change at each strobe. Applicable for phase 2 sequence.	
d88		STROBE_COUNT_PHASE 1	8UI	00	RW	Specifies how many strobes are counted during Phase1 of two types of sequences.	
d89		STROBE_COUNT_PHASE 2	8UI	00	RW Specifies how many strobe counted for Phase2 seque		

 Table 26. Sensor - high level auto focus registers [0x0d80 to 0x0d89]



# 4.2.18 Bracketing LUT registers [0x0e00 to 0x0e55]

Index	Byte	Register name	Data type	Default	Туре	Comment		
e00		bracketing_lut_ctrl	8UI	00	RW	Bracketing LUT Ctrl. 1-n - Bracketing over n frames		
e01		bracketing_lut_mode	8UI	00	RW	Bit[0] - Bracketing LUT Mode: 0 = return to SW standby after bracketing. 1 = continue in streaming after bracketing		
e02	н	bracketing_lut_entry_	1611	00		Bracketing LUT entry control		
e03	LO	control	1001	00		(Reserved).		
e10	HI	bracketing_lut_frame_a_	16111	00		Bracketing LUT frame A coarse		
e11	LO	coarse_int_time	1001	00		integration time		
e12	HI	bracketing_lut_frame_a_	16111	00		Bracketing LUT frame A analog gain		
e13	LO	analog_gain_code	1001	00		code		
e14	HI	bracketing_lut_frame_a_	1600	00		Bracketing LUT frame A digital gain		
e15	LO	digital_gain_gr	105K	00	RVV	GR		
e16	HI	bracketing_lut_frame_a_	16SP	00		Bracketing LUT frame A digital gain		
e17	LO	digital_gain_r	105K	00	- KVV	R		
e18	н	bracketing_lut_frame_a_	1650	00 00 RW	D\\/	Bracketing LUT frame A digital gain		
e19	LO	digital_gain_b	IUSK		1	В		
e1a	HI	bracketing_lut_frame_a_	16SR	00	D\\/	Bracketing LUT frame A digital gain GB		
e1b	LO	digital_gain_gb		00				
e1c	HI	bracketing_lut_frame_a_	16111	00	D\\/	Bracketing LUT frame A bracketing		
e1d	LO	bracketing_lut_entry	1001	00		LUT entry		
e1e	н	bracketing_lut_frame_b_	16111	00	D\\/	Bracketing LUT frame B coarse		
e1f	LO	coarse_int_time	1001	00	1	integration time		
e20	HI	bracketing_lut_frame_b_	16111	00	D\//	Bracketing LUT frame B analog gain		
e21	LO	analog_gain_code	1001	00		code		
e22	н	bracketing_lut_frame_b_	1650	00		Bracketing LUT frame B digital gain		
e23	LO	digital_gain_gr	IUSK	00		GR		
e24	HI	bracketing_lut_frame_b_	16SP	00		Bracketing LUT frame B digital gain		
e25	LO	digital_gain_r	IUSK	00		R		
e26	HI	bracketing_lut_frame_b_	1650	00		Bracketing LUT frame B digital gain		
e27	LO	digital_gain_b	NCOL	00		B		



Index	Byte	Register name	Data type	Default	Туре	Comment		
e28	HI	bracketing_lut_frame_b_	1650	00		Bracketing LUT frame B digital gain		
e29	LO	digital_gain_gb	IUSK	00		GB		
e2a	HI	bracketing_lut_frame_b_	1611	00	D\//	Bracketing LUT frame B bracketing		
e2b	LO	bracketing_lut_entry	1001	00		LUT entry		
e2c	HI	bracketing_lut_frame_c_	1611	00	D\//	Bracketing LUT frame C coarse		
e2d	LO	coarse_int_time	1001	00		integration time		
e2e	HI	bracketing_lut_frame_c_	1611	00	D\//	Bracketing LUT frame C analog gain		
e2f	LO	analog_gain_code	1001	00		code		
e30	HI	bracketing_lut_frame_c_	16SD	00		Bracketing LUT frame C digital gain		
e31	LO	digital_gain_gr	IUSK	00		GR		
e32	HI	bracketing_lut_frame_c_	1650	00		Bracketing LUT frame C digital gain		
e33	LO	digital_gain_r	IUSK	00		R		
e34	HI	bracketing_lut_frame_c_	1680	00		Bracketing LUT frame C digital gai		
e35	LO	digital_gain_b	IUSK	00	- KVV	В		
e36	HI	bracketing_lut_frame_c_	168D	00		Bracketing LUT frame C digital gain		
e37	LO	digital_gain_gb	1001	00	- KVV	GB		
e38	HI	bracketing_lut_frame_c_	16UI	00		Bracketing LUT frame C bracketing		
e39	LO	bracketing_lut_entry		00		LUT entry		
e3a	HI	bracketing_lut_frame_d_	16UI	00	RW	Bracketing LUT frame D coarse		
e3b	LO	coarse_int_time		00		integration time		
e3c	HI	bracketing_lut_frame_d_	4.01.11	00		Bracketing LUT frame D analog gain		
e3d	LO	analog_gain_code	1601	00	- KVV	code		
e3e	HI	bracketing_lut_frame_d_	1000	00		Bracketing LUT frame D digital gain		
e3f	LO	digital_gain_gr	105K	00	- KVV	GR		
e40	HI	bracketing_lut_frame_d_	1000	00		Bracketing LUT frame D digital gain		
e41	LO	digital_gain_r	165K	00	RVV	R		
e42	ні	bracketing_lut_frame_d_	1680	00		Bracketing LUT frame D digital gain		
e43	LO	digital_gain_b	165K	00	RVV	В		
e44	HI	bracketing_lut_frame_d_	1000	00		Bracketing LUT frame D digital gain		
e45	LO	digital_gain_gb	165K	00	RVV	GB		
e46	HI	bracketing_lut_frame_d_	4.01.11	00		Bracketing LUT frame D bracketing		
e47	LO	bracketing_lut_entry	16UI	00	KVV	LUT entry		
e48	HI	bracketing_lut_frame_e_	161.11	00		Bracketing LUT frame E coarse		
e49	LO	coarse_int_time	16UI	00	KVV	integration time		

|--|



Index	Byte	Register name	Data type	Default	Туре	Comment	
e4a	HI	bracketing_lut_frame_e_	1611	00	RW/	Bracketing LUT frame E analog gain	
e4b	LO	analog_gain_code	1001	00		code	
e4c	HI	bracketing_lut_frame_e_	1650	00		Bracketing LUT frame E digital gain	
e4d	LO	digital_gain_gr	105K	00		GR	
e4e	н	bracketing_lut_frame_e_	1650	00		Bracketing LUT frame E digital gain R	
e4f	LO	digital_gain_r	IUSK	00	L A A		
e50	HI	bracketing_lut_frame_e_	16SR	00	עעם	Bracketing LUT frame E digital gain B	
e51	LO	digital_gain_b		00	RVV.		
e52	н	bracketing_lut_frame_e_	1650	00		Bracketing LUT frame E digital gain GB	
e53	LO	digital_gain_gb	165R	00	RVV.		
e54	н	bracketing_lut_frame_e_	1611	00		Bracketing LUT frame E bracketing	
e55	LO	bracketing_lut_entry	1001	00	T V	LUT entry	

Table 27. Bracketing LUT registers [0x0e00 to 0x0e55] (continued)

### 4.2.19 Integration and gain limit registers [0x1000 to 0x1089]

Index	Byte	Register name	Data type	Default	Туре	Comment	
1000	HI	integration canability	1611	00	PO	This device supports coarse and	
1001	LO	Integration_capability	1001	01	ŇŎ	smooth (1 pixel) integration.	
1004	HI	min coarse	1611	00	PO	Minimum coarse integration time (in	
1005	LO		1001	00	NO	line periods).	
1006	н	coarse margin	1611	00	PO	Current frame length - current max coarse exposure (in line periods).	
1007	LO	coarse_margin	1001	09	NO		
1008	н	min fino	16UI	02	PO	Minimum fine integration time (in pixels).	
1009	LO			ae	ΝŪ		
100a	н	fine margin	16111	08	PO	Current line length - maximum fine	
100b	LO		1601	02	KU	exposure (pixel periods).	
1080	н	digital gain canability	16111	00	PO	This device supports digital gain.	
1081	LO	digital_gain_capability	1001	01	NO		
1084	н	digital gain min	16111	00	PO	Minimum supported digital gain	
1085	LO			08	ΝŪ	value.	
1086	н	digital gain may	16111	01	PO	Maximum supported digital gain	
1087	LO	digital_gain_max 16UI –		f8	ŇŪ	value	

 Table 28. Integration and gain limit registers [0x1000 to 0x1089]



Index	Byte	Register name	Data type	Default	Туре	Comment	
1088	HI	digital gain step size	16111	00	PO	Digital gain step size.	
1089	LO	ugital_gall1_step_size	1001	08	ŇŎ		

### Table 28. Integration and gain limit registers [0x1000 to 0x1089] (continued)

# 4.2.20 Video timing limit registers [0x1100 to 0x11c7]

Index	Byte	Register name	Data type	Default	Туре	Comment	
1100	HI			40			
1101	3rd	min ext clk freq	32111	c0	PO	Minimum external clock frequency	
1102	2nd		5201	00		ivinimum external clock nequency.	
1103	LO			00			
1104	н			41			
1105	3rd	may ext olk freq	32111	d8	PO	Maximum external clock frequency	
1106	2nd		3201	00		Maximum external clock nequency.	
1107	LO			00			
1108	HI	min pro pll clk div	16111	00	PO	Minimum value of pre-PLL clock divider.	
1109	LO		1001	01			
110a	HI	max pro pll alk div	16UI	00	RO	Maximum value of pre-PLL clock	
110b	LO	max_pre_pii_cik_div		04		divider.	
110c	HI		2011	40	RO		
110d	3rd	min oll in frog		c0		Minimum input clock frequency to the PLL.	
110e	2nd	nin_pii_ip_ireq	3201	00			
110f	LO			00			
1110	HI			41			
1111	3rd	may all in frag	22111	40		Maximum input clock frequency to	
1112	2nd	max_pii_ip_ireq	3201	00		the PLL.	
1113	LO			00			
1114	HI	min all multiplier	16111	00	DO		
1115	LO	min_pii_multipiier	16UI	4c	KU	Minimum PLL multiplier value.	
1116	HI	may all multiplier	16111	01	PO	Movimum DLL multiplior volue	
1117	LO	max_pii_muiupiiei	1001	4c	KU	Maximum PLL multiplier value.	

#### Table 29. Video timing limit registers [0x1100 to 0x11c7]



Index	Byte	Register name	Data type	Default	Туре	Comment	
1118	HI			44			
1119	3rd	min nll on frog	22111	61		Minimum DLL output froquency	
111a	2nd	nnn_pn_op_neq	3201	00		Minimum PLL output nequency.	
111b	LO			00			
111c	HI			44			
111d	3rd	may all on frog	22111	fa		Movimum DLL output frequency	
111e	2nd	max_pii_op_ireq	3201	00	KU	Maximum PLE output frequency.	
111f	LO			00			
1120	HI	and a star all all a	4.01.11	00		Minimum video timing system clock	
1121	LO	min_vt_sys_cik_div	1601	01	RU	divider value.	
1122	HI		4.01.11	00	50	Maximum video timing system clock	
1123	LO	max_vt_sys_clk_dlv	1601	04	RO	divider value.	
1124	HI		32UI	43			
1125	3rd			61	RO	Minimum video timing system clock frequency.	
1126	2nd	min_vt_sys_clk_freq		00			
1127	LO			00			
1128	HI		32UI	44	RO	Maximum video timing system clock frequency.	
1129	3rd			fa			
112a	2nd	max_vt_sys_clk_freq		00			
112b	LO			00			
112c	НІ			41		Minimum video timing pixel clock	
112d	3rd			fO			
112e	2nd	min_vt_pix_clk_freq 32UI	3201	00	RO	frequency.	
112f	LO			00			
1130	HI			43			
1131	3rd			28	-	Maximum video timing pixel clock	
1132	2nd	max_vt_pix_clk_freq	32UI	00	RO	frequency.	
1133	LO			00	-		
1134	НІ			00		Minimum video timing pixel clock	
1135	LO	min_vt_pix_clk_div	16UI	04	RO	divider value.	
1136	HI			00		Maximum video timing pixel clock	
1137	LO	max_vt_pix_clk_div	16UI	0a	RO	divider value.	
1140	н			00			
1141	LO	min_frame_length	16UI	d9	RO	Minimum frame length in lines.	

T	able 29.	Video	timing l	imit reg	gister	s [0x11	00 to 0	x11c7]	(continued)



Index	Byte	Register name	Data type	Default	Туре	Comment
1142	HI	max frame length	1611	ff	RO	Maximum frame length in lines
1143	LO		1001	ff		Maximum name lengur in intes.
1144	HI	min line length	16111	0a	PO	Minimum line length in nivel clocks
1145	LO		1001	be		
1146	HI	may line longth	16111	3f	PO	Movimum line longth in nivel clocks
1147	LO	Inax_ine_iengin	1001	ff		Maximum ine lengtr in pixel clocks.
1148	HI	min line blanking	16111	00	PO	Minimum line blanking in pixel
1149	LO	Thin_ine_blanking	1001	86		clocks.
114a	HI	min from blanking	16111	00	PO	Minimum frame blanking in lines
114b	LO	min_name_blanking	1601	16	KU	Minimum frame blanking in lines.
114c	HI	min_line_length_pck_	1611	00		Minimum step size of line length pck.
114d	LO	step_size	1601	01	KU	
1160	HI	min on ava alle div	16UI	00		Minimum output timing system clock
1161	LO	min_op_sys_cik_div		01	ĸo	divider value.
1162	HI		16UI	00	RO	Maximum output timing system clock
1163	LO	max_op_sys_cik_div		14		divider value.
1164	HI		32UI	42	RO	Minimum output timing system clock frequency.
1165	3rd	min on ave alle frog		34		
1166	2nd	min_op_sys_cik_freq		00		
1167	LO			00		
1168	HI			44		
1169	3rd		20111	fa		Maximum output timing system clock
116a	2nd	max_op_sys_cik_freq	3201	00	RU	frequency.
116b	LO			00		
116c	HI	and a site all all a	4.01.11	00		Minimum output timing pixel clock
116d	LO	- min_op_pix_cik_aiv	1601	06	RO	divider value.
116e	HI		4.01.11	00		Maximum output timing pixel clock
116f	LO	- max_op_pix_cik_div	1601	0a	RO	divider value.
1170	HI			40		
1171	3rd		20171	90		Minimum output timing pixel clock
1172	2nd	_mm_op_pix_cik_freq	3201	00		frequency.
1173	LO			00	1	

Table 29. Video timing limit registers [0x1100 to 0x11c7] (continued
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Index	Byte	Register name	Data type	Default	Туре	Comment
1174	HI			43		
1175	3rd	moy on nix alk frog	20111	28	PO	Maximum output timing pixel clock
1176	2nd	max_op_pix_cik_fieq	3201	00	KU	frequency.
1177	LO			00		
1180	НІ	v oddr min	16111	00	PO	
1181	LO		1001	00	KU	
1182	HI	v oddr min	16111	00	PO	
1183	LO		1001	00	KU	Ninimum TADDR value.
1184	HI	v oddr mov	16111	0a	DO	
1185	LO	x_addi_max	1601	27	RU	
1186	HI	v oddr mov	07		DO	
1187	LO	y_addi_max	1601	9f	RU	Waximum TADDR Value.
1188	HI	v en eine min	16UI	01	RO	
1189	LO	x_op_size_min		00		
118a	HI	v op oizo min	16UI	00	RO	Minimum Y output size in lines.
118b	LO	y_op_size_min		c0		
118c	НІ	y op size mey	4.01.11	0a		Movimum X output oizo in pixelo
118d	LO		1601	28	KU	
118e	HI	y en eize mey	16111	07	DO	Movimum V output cize in lines
118f	LO	y_op_size_max	1601	a0	RU	Maximum r output size in lines.
11c0	HI	oven ine min	16111	00	PO	Minimum even increment used in
11c1	LO	even_inc_min	1001	01	KU	digital subsampling.
11c2	н	oven ine mer	16111	00	PO	Maximum even increment used in
11c3	LO	even_inc_max	1001	01	KU	digital subsampling.
11c4	HI	add inc. min	1611	00	DO	Minimum odd increment used in
11c5	LO		1001	01		digital subsampling.
11c6	HI	odd inc max	161.11	00	PO	Maximum odd increment used in
11c7	LO			13		digital subsampling.



# 4.2.21 Scaling limit registers [0x1200 to 0x120f]

Index	Byte	Register name	Data type	Default	Туре	Comment
1200	HI	scaling canability	16111	00	PO	VB6955CM supports horizontal
1201	LO	scaling_capability	1001	01	NO	digital scaling
1204	HI	scalo m min	16111	00	PO	Minimum M value for downscale
1205	LO		1001	10	NO	winimum wi value for downscale.
1206	HI		16111	00	PO	Maximum M value for downgoole
1207	LO		1601	a3	KU	
1208	HI	acolo n min	16111	00	DO	Minimum Nuclus for downsoils
1209	LO		1601	10	RU	Minimum N value for downscale.
120a	HI		16111	00	DO	Maximum Nuclus for downsoils
120b	LO	scale_n_max	1601	10	RU	Maximum N value for downscale.
120c	HI	spatial sampling		00		Spatial sampling capability
120d	LO	capability	16UI	03	RO	Bayer sampling supported 2 or 4 component co-sited supported
120e	HI			00		Digital crop is supported.
120f	LO	digital_crop_capability	16UI	01	RO	Note. This should be a 8 bit register. i.e. The value for 0x120E should be 01

Table 30.	Scaling	limit	registers	[0x1200 to	0x120f1
14010 001	oounig		109101010	[0/1700 00	0

### 4.2.22 Compression capability registers [0x1300 to 0x1301]

#### Table 31. Compression capability registers [0x1300 to 0x1301]

Index	Byte	Register name	Data type	Default	Туре	Comment
1300	ні	comprossion capability	16UI	00	RO	Compression capability is DPCM/PCM.
1301	LO	compression_capability		01		

# 4.2.23 Derate capability registers [0x1500 to 0x1502]

Index	Byte	Register name	Data type	Default	Туре	Comment
1500	HI	fifo cizo pixolo	16UI	00	RO	FIFO size in pixels (derate sync RAM).
1501	LO			00		
1502	HI	fifo_support_capability	8UI	01	RO	VB6955CM supports derating

#### Table 32. Derate capability registers [0x1500 to 0x1502]



# 4.2.24 DPHY capability registers [0x1600 to 0x1604]

Index	Byte	Register name	Data type	Default	Туре	Comment
1600		dphy_ctrl_capability	8UI	03	RO	CSI2 DPHY control capability: Automatic DPHY control supported. UI based DPHY control supported.
1601		csi_lane_mode_capability	8UI	03	RO	1 and 2 lane supported.
1602		csi_signalling_mode_ capability	8UI	07	RO	CCP2 data/clock supported. CCP2 data/strobe supported. CSI2 supported.
1603		fast_standby_capability	8UI	01	RO	Fast standby is supported for rolling shutter).
1604		cci_address_control_ capability	8UI	07	RO	VB6955CM supports: – SW changeable CCI address – 2nd CCI address. – 2nd SW changeable CCI address.

#### Table 33. DPHY capability registers [0x1600 to 0x1604]

### 4.2.25 Bitrate limit registers [0x1608 to 0x1617]

Table 34. Bitrate	limit reg	jisters [0x	1608 to	0x1617]

Index	Byte	Register name	Data type	Default	Туре	Comment
1608	HI			03		Maximum bitrate for a 1 lane configuration.
1609	3rd	max_per_lane_bitrate_1_	321 IP	e8	RO	
160a	2nd	lane_mode_mbps	3201	00		
160b	LO			00		
160c	HI		32UR	03	RO	Maximum bitrate for a 2 lane configuration.
160d	3rd	max_per_lane_bitrate_2_ lane_mode_mbps		e8		
160e	2nd			00		
160f	LO			00		



# 4.2.26 Binning capability registers [0x1700 to 0x1714]

Index	Byte	Register name	Data type	Default	Туре	Comment
1700	HI	min_frame_length_lines_	1611	00	PO	Minimum frame length (lines)
1701	LO	bin	1601	d9	KU	allowed in binning mode.
1702	н	max_frame_length_lines_	1611	ff	PO	Maximum possible number of lines
1703	LO	bin	1601	ff	KU	per frame in binning mode.
1704	HI	min line length net hin	16111	0a	DO	Minimum line length (pixel clocks)
1705	LO	min_ine_iengtn_pck_bin	1601	be	RU	allowed in binning mode.
1706	HI	may line length not his	16111	3f	DO	Maximum possible number of pixel
1707	LO	max_ime_iengtn_pck_bin	1601	ff	RU	clocks per line in binning mode.
1708	HI	min_line_blanking_pck_ bin	46111	00	RO	Minimum line blanking time in pixel clocks in binning mode.
1709	LO		1001	86		
170a	HI	fine_integration_time_	16UI	02	RO	Minimum fine integration time allowed in binning mode (in pixels).
170b	LO	min_bin		51		
170c	н	fine integration time	16UI	09		Margin used to determine the maximum fine integration time allowed in binning mode (in pixels).
170d	LO	max_margin_bin		d8	RO	
1710		binning_capability	8UI	01	RO	Binning supported
1711		binning_weighting_ capability	8UI	01	RO	Binning weighting capability: Averaged weighting supported
1712		binning_sub_types	8UI	02	RO	Number of binning subtypes available.
1713		binning_type_1	8UI	22	RO	Binning type is 2 x 2 (Col x Row).
1714		binning_type_2	8UI	44	RO	Binning type is 4 x 4 (Col x Row).

#### Table 35. Binning capability registers [0x1700 to 0x1714]

# 4.2.27 Data transfer capability registers [0x1800]

#### Table 36. Data transfer capability registers [0x1800]

Index	Byte	Register name	Data type	Default	Туре	Comment
1800		data_xfer_if_capability	8UI	0d	RO	Data transfer capability. I/F1 supported Polling not needed in reading or writing



### 4.2.28 Ideal raw capability registers [0x1900 to 0x1907]

Index	Byte	Register name	Data type	Default	Туре	Comment		
1900		shading_correction_ capability	8UI	00	RO	Shading correction not supported.		
1901		green_imbalance_ capability	8UI	00	RO	Green imbalance not supported		
1902		black_level_capability	8UI	01	RO	Black level correction supported.		
1903		module_specific_ correction_capability	8UI	00	RO	Module specific correction not supported		
1904	н	defect_correction_	16111	00	PO	Mapped couplet defect correction		
1905	LO	capability	1001	01	NO	supported.		
1906	н	defect_correction_	16111	00	PO	Defect correction conchility 2		
1907	LO	capability_2	1001	00		Defect correction capability 2.		

#### Table 37. Ideal raw capability registers [0x1900 to 0x1907]

### 4.2.29 EDOF capability registers [0x1980 to 0x19c5]

#### Table 38. EDOF capability registers [0x1980 to 0x19c5]

Index	Byte	Register name	Data type	Default	Туре	Comment
1980	edof_capability		8UI	00	RO	EDoF not supported.

# 4.2.30 Timer capability registers [0x1a00 to 0x1a02]

#### Table 39. Timer capability registers [0x1a00 to 0x1a02]

Index	Byte	Register name	Data type	Default	Туре	Comment	
1a00	HI	capability trdy min	16111	00	PO	Minimum value	
1a01	LO	capability_truy_truit	1001	00	ŇŎ		
1a02		flash_mode_capability	8UI	03	RO	Flash mode capability: Single and multiple flash strobe supported	



### 4.2.31 Mechanical shutter capability registers [0x1b00 to 0x1b04]

Index	Byte	Register name	Data type	Default	Туре	Comment	
1b00		mech_shut_and_act_cci_ addr	8UI	00	RO	Mechanical shutter and actuator CCI address. 7-bit address. Address can point to, for example, camera module main chip, but also to, for example, separate lens driver chip.	
1b02	HI	mech_shut_and_act_	1611	00	RO	Defines start address in CCI space.	
1b03	LO	start_addr	1001	00	ŇŎ		
1b04		actuator_capability	8UI	04	RO	Actuator capability: Mechanical shutter not supported AF actuator supported	

Table 40. Mechanical shutter capability registers [0x1b00 to 0x1b04]

### 4.2.32 Static autofocus actuator capability registers [0x1b40 to 0x1b45]

Index	Byte	Register name	Data type	Default	Туре	Comment
1b40	н			00		Actuator type:
1b41	LO	actuator_type	16UI 81		RO	Bit[0] - Linear Bit[7] - Actuator with home position at far mechanical end
1b42		af_device_address	8UI	20	RO	Specifies the device CCI address of focusing control device.
1b44	н	focus change address	16111	0d	PO	Specifies the start address of high
1b45	LO	locus_change_audress	1001	80		level command set

### Table 41. Static autofocus actuator capability registers [0x1b40 to 0x1b45]

### 4.2.33 Bracketing LUT capability registers [0x1c00 to 0x1c02]

#### Table 42. Bracketing LUT capability registers [0x1c00 to 0x1c02]

Index	Byte	Register name	Data type	Default	Туре	Comment
1c00		bracketing_lut_1_ capability	8UI	1b	RO	Bracketing interface LUT 1 capability The following is supported: – Coarse integration time – Global analog gain – Per channel digital gain – Flash



						,
Index	Byte	Register name	Data type	Default	Туре	Comment
1c01		bracketing_lut_2_ capability	8UI	00	RO	Bracketing interface LUT 2 capability (Reserved)
1c02		bracketing_lut_size_ capability	8UI	05	RO	LUT can contain settings for five frames

#### Table 42. Bracketing LUT capability registers [0x1c00 to 0x1c02] (continued)

# 4.2.34 Manufacturer specific registers [0x6006 to 0x6008]

Index	Byte	Register name	Data type	Default Type Co		Comment			
6006		datalane1_ctrl	8UI	00	RW	Bit0: Invert data lane, P & N function Bit1: Swap data lane, P & N function			
6007		datalane2_ctrl	8UI	00	RW	Bit0: Invert data lane, P & N function Bit1: Swap data lane, P & N function			
6008		clklane_ctrl	8UI	00	RW	Bit0: Invert clock lane, P & N function Bit1: Swap clock lane, P & N function			
fadf		af_delay	8UI	03	RW	This register controls the delay between setting bit 0 of the focus_change_control register (0x0d83) and it being cleared. This value should be 0x00			

#### Table 43. Manufacturer specific registers [0x6006 to 0x6008]



# 5 Video data interface

The video stream output from the VB6955CM through the compact camera port (CCP) or camera serial interface (CSI) contains both video data and other auxiliary information. This section describes the frame formats.

The VB6955CM is SMIA version 1.0 and MIPI CSI-2 version 1.00 and D-PHY 1.0 compliant.

The selection of the video data format is controlled using the following register: CSI\_SIGNALLING\_MODE (0x0111)

- 0 CCP2 data/clock
- 1 CCP2 data/strobe
- 2 CSI-2 (default)

Changing the video data format must be performed when the sensor is in software standby.

- The VB6955CM supports maximum output data rates of 1.68 Gbps using a dual lanes interface (840 Mbps). However, the data rate is limited to 1.0 Gbps when operated in CSI-2 single lane mode.
- The VB6955CM CCP lane is capable of transmitting at 640 Mbps.
- The CSI-2 data lane transmitter supports:
  - unidirectional master
  - HS-TX
  - LP-TX (ULPS)
  - CIL-MUYN function
- The CSI-2 clock lane transmitter supports:
  - unidirectional master
  - HS-TX
  - LP-TX (ULPS)
  - CIL-MCNN function



# 5.1 Frame format

The frame format for the VB6955CM is described by the frame format description registers, see *Table 11*. For CCP2 this results in a frame as shown in *Figure 9* and for CSI-2 it results in a frame as shown in *Figure 10*.



Figure 9. VB6955CM CCP2 frame format





Figure 10. VB6955CM CSI-2 frame format

#### **Embedded data lines**

The embedded data lines provide a mechanism to embed non-image data such as sensor configuration details within the output data stream. The number of embedded data lines at the start and end of the frame is specified as part of the frame format description. VB6955CM has three embedded data lines.

#### Dummy pixel data

This is invalid pixel data. The receiver should always ignore dummy pixel data. The VB6955CM has eight dummy columns.



#### Visible pixel data

The visible pixels contain valid image data. The correct integration time and analog gain for the visible pixels is specified in the blank lines at the start of the frame. The number of visible pixels can be varied with the requested frame size.

#### Dark pixel data (light shielded pixels)

The VB6955CM has 0 dark pixels.

#### Black pixel data (zero integration time)

The VB6955CM has 0 black pixels.

#### Manufacturer specific pixel data

The VB6955CM has 0 manufacturer specific pixels.

#### Interline padding/line blanking

During interline padding all bits in the data stream in a CCP2 frame are set to 1.

In a CSI-2 frame there is no concept of line blanking being transmitted, the sensor simply spends a longer time in the LP state between active line data.

#### Interframe padding/frame blanking

During interframe padding all bits in the data stream in a CCP2 frame are set to 1.

In a CSI-2 frame there is no concept of frame blanking being transmitted, the sensor simply spends a longer time in the LP state at the end of the active data for a frame.



# 6 Video timing

### 6.1 Output size

The VB6955CM has the following methods available to achieve the required output size, these can be used independently or in conjunction with any other:

- analog crop, see Section 6.1.1
- subsampling, see Section 6.1.2
- binning, see Section 6.1.3
- digital cropping, see Section 6.1.4
- scaling, see Section 6.1.5
- output crop, see Section 6.1.6

The programmable image size and output size are independent functions. It is the responsibility of the host to ensure that these functions are programmed correctly for the intended application. These functions also reduce the amount of data and therefore reduce the peak data rate of CCP2/CSI-2.



#### Figure 11. Data flow



### 6.1.1 Analog crop

The native size for the VB6955CM is 2592 x 1944, the maximum addressable array is 2600 x 1952 which gives border pixels (outer 4 rows and 4 columns) for the color reconstruction algorithms to use at the edges of the array.

By programming the x\_addr\_start, y\_addr\_start, x\_addr\_end and y\_addr\_end registers it is possible to use the full size of the array as you would do for a native size output or you can select a "window of interest". The addressed region of the array is used in any subsequent subsampling or scaling.





The host must ensure the following rules are kept;

- the end address must be greater than the start address
- the x and y start addresses are restricted to even numbers only, and the x and y end addresses are restricted to odd numbers only, to ensure that there is always a even number of pixels read out



### 6.1.2 Subsampling

Subsampling is achieved by programming the x\_odd\_inc and y\_odd\_inc registers.

If the pixel being readout has an even address then the address is incremented by the even increment value either x\_even\_inc or y\_even\_inc. If the pixel being readout has an odd address then the address is incremented by the odd increment value either x\_odd\_inc or y\_odd\_inc.

The subsampled readout is disabled by setting the odd and even increment values to 1. (The even increment must always be set to 1.)

Subsampling acts upon the addressed region of the array which is determined by the x\_addr\_start, y\_addr\_start, x\_addr\_end and y\_addr\_end registers.

The equation for the sub-sampling factor is given below:





### 6.1.3 Binning

The VB6955CM also has a binning mode, sometimes also referred to as analogue Bayer scaling, that offers a reduced size full field of view image. The pixel binning mode averages row and column pixel data.

The binning mode results in a reduced number of lines and so can be used to give a higher image frame rate. Compared to subsampling, analog binning makes use of the light gathered from the whole pixel array and it results in higher image quality.

The binning mode is scaled by  $2 \times 2$  or by  $4 \times 4$  in the X and Y direction.

#### 6.1.4 Digital crop

Digital crop can be used in addition to or instead of the analog crop function. It occurs after the subsampling function. It is affected by the amount of subsampling as well as by the analog crop. Since the input to the digital crop block is variable, there are no limit registers associated with digital crop.



Figure 14. Digital crop

The host must ensure the following rule is kept:

• the x and y offsets and the image width and height are restricted to even numbers only

Note: In VB6955CM it is mandatory to maintain a consistency between y\_output\_size and digital\_crop\_image\_height to have a similar value.



#### 6.1.5 Scaling

The VB6955CM is compliant with the SMIA Profile Level 1 - Full horizontal level of image scaling.

The image scaling function within the sensor provides a flexible way of generating lower resolution full field of view image data, at a reduced data rates, for viewfinder and video applications.

The scaler is able to scale the full resolution of the sensor down to within 10% of a the target image size (the smallest output size is 256x192). This flexibility means that the VB6955CM can support a wide range of LCD viewfinder sizes and different codec resolutions.

The VB6955CM has two scaling modes which are controlled by the scale\_mode\_req register shown in *Figure 15*.





#### **Scaler quality**

The scaler supports two options for the spatial sampling of the scaled image data (see *Figure 16*).

• Bayer sampled scaled image data

The sampling point for the scaler for the output Gr value appears to be in the centre of the Gr pixel (that is between the first and second pixels and between the first and second rows of the original input Bayer pixel data). The R (or B) sampling points are similarly in the centre of the R pixel (or B pixel).

• Co-sited scaled image data

The sampling point for the Gr, R. Gb and B vales in each output 'quad' are functions of the same color input array pixels such that the spatial sampling point for all four appears to be in the centre of the 'quad' that is between the second and third pixels and between the first and second rows.

The spatial sampling mode is controlled by the scale\_cosite\_req register.



	<b>J</b>	
Pixel array output	Bayer sampled scaling	Co-sited sampling

Figure	16.	Scaler	qual	ity
--------	-----	--------	------	-----

#### Down scaler factor

The down scaler factor is controlled by an M/N ratio, scale\_m is >= 16 and scale\_n is fixed at 16. scale\_m is in the range 16 to 164.

down\_scale\_factor =  $\frac{scale_m}{scale_n} = \frac{scale_m}{16}$ 

This single down scale factor is used by the horizontal scalers. The scaler acts upon the addressed region of the array which is determined by the x\_addr\_start, y\_addr\_start, x\_addr\_end and y\_addr\_end registers.







#### 6.1.6 Output crop

The x\_output\_size and y\_output\_size registers are not intended as the primary cropping controls.

They are intended to define the position of the LE/FE codes in the CCP2 and CSI-2 data frame to comply with SMIA CCP2 and MIPI CSI-2 data format rules. It is expected that the host sets the output sizes to exactly enclose the output image data. If the host does not do this, the VB6955CM treats the output sizes as being calculated from the top left hand corner of the output array. So in the case where output sizes are smaller than the output data, the data is cropped from its right hand and lower limits. In the case where larger than the output data, the lines are padded out to the defined output size with undefined data.





Note:

CCP2 requires that the CCP output active line length (between start and end sync codes) for RAW8 is a multiple of 4 and for RAW10 is a multiple of 16.

CSI-2 requires that RAW8 is a multiple of 2 pixels (actual definition is 1 pixel but 2 are required to preserve the Bayer pattern) and RAW10 is a multiple of 4 pixels (40 bits).

The host must control the x\_output\_size to ensure that the CCP output active line length meets the above criteria.



### 6.2 Video timing

This section specifies the timing for the image data that is read out from the pixel array and the output image data. These are not necessarily the same size.

The application of all of the video timing read/write parameters must be re-timed to the start of the frame boundary to ensure that the parameters are consistent within a frame. The video stream which is output from the VB6955CM contains both video data and other auxiliary information.

#### 6.2.1 PLL block

The VB6955CM contains a phase locked loop (PLL) block, which generates all the necessary internal clocks from the external clock input. Changes to the PLL settings on the VB6955CM are only consumed on the software standby to streaming mode transition.

*Figure 19* shows the internal functional blocks, which define the relationship between the external input clock frequency and the pixel clock frequency.

The majority of the logic within the device is clocked by vt\_sys\_clk however the CCI block is clocked by the external input clock.



#### Figure 19. VB6955CM clock relationships

The equations relating the input clock frequency to pixel clock frequencies are given below.

vt\_pix\_clk\_freq\_mhz =  $\frac{\text{ext_clk_freq_mhz \times pll_multiplier}}{\text{pre_pll_clk_div \times vt_sys_clk_div \times vt_pix_clk_div}}$ op\_pix\_clk\_freq\_mhz =  $\frac{\text{ext_clk_freq_mhz \times pll_multiplier}}{\text{pro_pll_clk_div \times op_siv_clk_div \times op_pix_clk_div}}$ 

pre\_pll\_clk\_div × op\_sys\_clk\_div × op\_pix\_clk\_div



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#### 6.2.2 Framerate

The framerate of the array readout and therefore the output framerate is governed by the line length, frame length and the video timing pixel clock frequency.

- Line length is specified as a number of pixel clocks, line\_length\_pck.
- Frame length is specified as a number of lines, frame\_length\_lines.
- Video timing pixel clock is specified in MHz, vt\_pix\_clk\_freq\_mhz.

The equation relating the framerate to the Line length, frame length and the video timing pixel clock frequency is given below:.

The maximum frame rate that can be achieved in profile 0 is 30 fps with CSI2 dual lane. *Table 44* provides examples of frame timing for Raw10 mode for 30 fps for a variety of external clock frequencies.

Ext clk freq	Pre-PLL clk div	PLL multiplier	VT sys clk div	VT pixel clk div	VT pixel clock	OP sys clk div	OP pixel clk div	OP pixel clock	Line length	Frame length
MHz	Integer	Integer (Dec)	Integer	Integer	MHz	Integer	Integer	MHz	Pixel Clks	Lines (Dec)
9.60	1	174	1	10	167.0	1	10	167.0	2750	1988
12.00	2	280	1	10	168.0	1	10	168.0	2750	1988
13.00	2	258	1	10	167.7	1	10	167.7	2750	1988

Table 44. External clock frequency examples - 5.0 Mpixel Raw10 30 fps (CSI-2 dual lane)

*Table 45* provides examples of frame timing for Raw10 mode for 15 fps with CSI-2 single lane for a variety of external clock frequencies.

Ext clk freq	Pre-PLL clk div	PLL multiplier	VT sys clk div	VT pixel clk div	VT pixel clock	OP sys clk div	OP pixel clk div	OP pixel clock	Line length	Frame length
MHz	Integer	Integer (Dec)	Integer	Integer	MHz	Integer	Integer	MHz	Pixel Clks	Lines (Dec)
9.60	1	176	2	10	84.48	2	10	84.48	2750	1988
12.00	2	280	2	10	84.00	2	10	84.00	2750	1988
13.00	2	258	2	10	83.85	2	10	83.85	2750	1988

Table 45. External clock frequency examples - 5.0 Mpixel Raw10 15 fps (CSI-2 single lane)



### 6.2.3 Derating

To provide a wide range of data rate reduction options, the full image scaler is able to reduce the data and therefore data rates in both the horizontal and vertical directions. In the VB6955CM this is achieved by the use of a FIFO between video timing and output clock domains.

It is therefore necessary for the host to configure the OP clock domain to ensure that the FIFO neither over flows or under flows.



Figure 20. Timing block diagram

Derating shows the difference between the video timing domain and the output clock domain.

derating = \_\_\_\_\_\_op\_sys\_clk\_div \* \_\_\_\_op\_pix\_clk\_div \_\_\_\_\_vt\_sys\_clk\_div \* \_\_\_\_vt\_pix\_clk\_div



#### FIFO

The FIFO is used to implement the data rate reduction required for profile 1 operation.

The concept of an output frame length and a line length for the output timing domain does not exist for SMIA devices such as the VB6955CM. This is a result of the FIFO input data patterns being different depending on scaling factor and if the data is co-sited or Bayer sampled, which results in variable interframe and interline blanking time between lines and between frames.







# 6.3 Image and video size capabilities

The VB6955CM supports various video modes ranging from VGA@120 fps to HD formats like 3.8 Mpixel @ 42 fps, 1080p30 and 720p30.

The VB6955CM has two CSI-2 data lanes capable of transmitting up to:

- 1.68 Gbps in dual lane mode (840 Mbps per lane)
- 1.0 Gbps in single lane mode

	Resolution	FPS	Mode	Format	Number of CSI2 interfaces	Lane data rate (Mbps)
	2600 x 1952	23 (max)	5 Mpixel 4:3	RAW8, 10/8	1 lane	996
Full FOV     26       10     10       HD     10       video     10       rate     10       video     10       72     72       VGA     VG	2600 x 1952	31 (max)	5 Mpixel 4:3	RAW10	2 lanes	840
	1080p	41 (max)	16:9 (full horizontal + vertical crop)	RAW8, 10/8	1 lane	996
HD video capture	1080p	55 (max)	16:9 (full horizontal + vertical crop)	RAW8, 10/8	2 lanes	672
	1080p	33 (max)	16:9 (full horizontal + vertical crop)	RAW10	1 lane	996
	1080p	55 (max)	16:9 (full horizontal + vertical crop)	RAW10	2 lanes	840
	720p	61 (max)	3.8 Mpixel 16:9 + Binning 2x2	RAW8, 10/8	1 lane	996
	720p	82 (max)	3.8 Mpixel 16:9 + Binning 2x2	RAW10	2 lanes	840
	VGA (648x488)	89	5 Mpixel 4:3 with Binning 2x2 + 2x2 subsampling	RAW8, 10/8	1 lane	996
VGA	VGA (648x488)	120	5 Mpixel 4:3 with Binning 2x2 + 2x2 subsampling	RAW8, 10/8	2 lanes	672
	VGA (648x488)	120	5 Mpixel 4:3 with Binning 2x2 + 2x2 subsampling	RAW10	2 lanes	840
WVGA	WVGA (800x480)	120	1.5 Mpixel + Binning 2x2	RAW10	2 lanes	840

Table 46	Framples	of video	mode	canabilities
1abie 40.		UI VIUEU	moue	capapilities

# 6.4 Bayer pattern

The three color (Red, Green, Blue) filters are arranged over the pixel array in a repeated 2 x 2 arrangement known as the Bayer Pattern. When the pixel array is read, the output order of red, green, blue depends on the settings of vertical flip and horizontal mirror.

*Figure 22* shows the read-out order for the default settings of vertical flip and horizontal mirror both turned off. Vertical flip changes the first line to be output from a green/red line to a blue/green line and horizontal mirror changes the sequence within a line, for example, green/red to red/green.

As shown in *Figure 22*, the first pixel to be readout from the imaging array is green followed by red.

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### 6.5 Image compression

The objective of image compression is to reduce the required bandwidth in transmission between the sensor and the host.

The key features of the DPCM/PCM compression algorithm are:

- visually lossless
- low cost implementation (no line memories are required)
- fixed rate compression

The 10-bit to 8-bit DPCM/PCM image compression algorithm is supported by VB6955CM. 10-bit to 8-bit compression has the additional advantage that one pixel value equals one byte of data.

The level of compression is controlled through the CSI\_data\_format register. The same register is also used to enable and disable compression.

The compression\_mode register is used to select which compression algorithm is used. Currently only the DPCM/PCM technique is supported. Therefore the value of this register is always 0x01.

The compression\_capability register tells the host whether a sensor does or does not have compression and if it has compression then what is the compression technique. Currently only the DPCM/PCM technique is supported.

Also refer to section 10 of the SMIA1.0 specification document.

### 6.6 Exposure and gain control

VB6955CM does not contain any form of automatic exposure control. To produce a correctly exposed image the integration period and analogue gain for the pixels must be calculated by an exposure control algorithm implemented externally. The parameters are then written to the VB6955CM through the CCI interface.

The exposure control parameters available on VB6955CM are:

- fine integration time
- coarse integration time
- analog gain
- digital gain

The exposure control parameter registers are defined in Section 4.2.6.

Integration time and analogue gain capability registers should be used to determine the exposure control parameter limits for a given video timing configuration. See Section 6.7 of the SMIA 1.0 part 1 specification for more information on how to interpret the integration and gain capability registers and how to calculate exposure and gain limits.

### 6.6.1 Analogue gain model

VB6955CM only supports the single global analogue gain mode. VB6955CM has a 16-bit register (0x0204 and 0x0205) to control analogue gain. However, only 4 bits are supported by the SMIA 1.0 description. Two extra bits can be used for fine gain between values 8 and 16 but their description is not currently supported by SMIA 1.0 specification.

*Figure 23* shows the way the analogue gain bits are used for VB6955CM. **Use only Coarse Gain bits for standard 1/x functionality**.

Figure 23. Analogue gain register format



The following generic equation describes VB6955CM coarse gain behavior specified by the analogue gain description registers 0x008A to 0x0093:

gain = 
$$c0/(m1 \cdot x + c1)$$

where:

m1 = -1 c0 = 256 c1 = 256

Table 47 specifies the valid analogue gain values for VB6955CM.

		<u> </u>		
Gain value (0x0204/0x0205)	Coarse gain code [A7:A4]	Coarse analogue gain	Fine gain code [A3:A2]	Fine analogue gain
0x0000	0000	0.0 dB (x1.00)	00	N/A
0x0010	0001	0.6 dB (x 1.07)	00	N/A
0x0020	0010	1.1 dB (x1.14)	00	N/A
0x0030	0011	1.8 dB (x1.23)	00	N/A
0x0040	0100	2.5 dB (x1.33)	00	N/A
0x0050	0101	3.2 dB (x1.45)	00	N/A
0x0060	0110	4.1 dB (x1.60)	00	N/A
0x0070	0111	5.0 dB (x1.78)	00	N/A
0x0080	1000	6.0 dB(x2.00)	00	N/A
0x0090	1001	7.2 dB (x2.29)	00	N/A
0x00A0	1010	8.5 dB (x2.66)	00	N/A
0x00B0	1011	10.1 dB (x3.20)	00	N/A
0x00C0	1100	12.0 dB (x4.00)	00	N/A
0x00D0	1101	14.5 dB (x5.33)	00	N/A
0x00E0	1110	18.1 dB (x8.00)	00	N/A

Table 47	. Analogue	gain	control
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Gain value (0x0204/0x0205)	Gain value (0x0204/0x0205) Coarse gain code [A7:A4]		Fine gain code [A3:A2]	Fine analogue gain	
0x00E4	1110	fine ctrl	01	19.2 dB (x9.14)	
0x00E8	1110	fine ctrl	10	20.6 dB (x10.66)	
0x00EC	1110	fine ctrl	11	22.1 dB (x12.80)	
0x00F0	1111	24.1 dB (x16.00)	00	N/A	

Table 47. Analogue gain control (continued)

Also refer to section 6.3 of the SMIA1.0 specification document.

### 6.6.2 Digital gain

To help compensate for the relatively coarse analogue gain steps, VB6955CM contains a digital multiplier to "fill" in the missing steps. By mixing analogue and digital gain it is possible to implement 3% gain steps across the full 1x to 16x gain range

The details of the digital gain implementation are listed below:

- four individual 16-bit digital channel gains one per Bayer channel
- digital\_gain\_greenR (0x020E and 0x020F)
- digital\_gain\_red (0x0210 and 0x0211)
- digital\_gain\_blue (0x0212 and 0x0213)
- digital\_gain\_greenB (0x0214 and 0x0215)
- the digital gain range for each channel is 1.000 to 1.96875 in steps of 0.03125 (1/32), that is, 5 fractional bits
  - digital\_gain\_min  $\{0x1084:0x1085\} = 0x0100 (1.00)$
  - digital\_gain\_max {0x1086:0x1087} = 0x01F8 (1.96875)
  - digital\_gain\_step {0x1088:0x1089} = 0x0008 (0.03125)

### 6.6.3 Integration and gain parameter re-timing

The modification of exposure parameter (integration time, analog and digital gain) register values does not take effect immediately.

The exact time at which changes to certain parameters take effect is controlled both to ensure that each frame of image data produced has consistent settings and that changes in groups of related parameters can be synchronized.

A group of parameter changes is marked by the host using a dedicated Boolean control parameter, grouped\_parameter\_hold (register 0x0104). Any changes made to 'retimed' parameters while the grouped\_parameter\_hold signal is in the 'hold' state will be considered part of the same group. Only when the grouped\_parameter\_hold control signal is moved back to the default 'no-hold' state will the group of changes be executed.



# 7 Electrical characteristics

# 7.1 Absolute maximum ratings

Symbol	Parameter	Minimum	Maximum	Unit
VDIG <sub>MAX</sub>	Digital power supply	-0.5	2.2	V
VANA <sub>MAX</sub>	Analog power supply	-0.5	3.2	V
VBAT <sub>MAX</sub>	VBAT power supply	-0.3	5.5	V
V <sub>IHMAX</sub>	CCI signals, system clock input	-0.5	2.2	V
T <sub>STO</sub>	Storage temperature	-40	+85 <sup>(1)</sup>	°C
V <sub>ESD</sub>	Electrostatic discharge model Human body model Charge device model <sup>(2)</sup>	-2.0 -250	2.0 250	kV V

#### Table 48. Absolute maximum ratings

1. This is a maximum long term standard storage temperature, see soldering profile for short term high temperature tolerance.

2. CDM tests are performed in compliance with JESD22-C101D.

**Caution:** Stresses above those listed under "Absolute maximum ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of the specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



# 7.2 Operating conditions

	······································									
Symbol	Parameter	Minimum	Typical	Maximum	Unit					
Voltage										
VDIG	Digital power supply	1.62	1.80	1.98	V					
VANA	Analog power supply	2.6	2.80	2.9	V					
VBAT	VBAT power supply	2.5		4.8	V					
Temperatu	re	· · · · · · · · · · · · · · · · · · ·		· · · ·						
T <sub>AS</sub>	Temperature (storage) <sup>(1)</sup>	-40	-	+85	°C					
T <sub>AF</sub>	Temperature (functional operating) <sup>(2)</sup>	-30	-	+70	°C					
T <sub>AN</sub>	Temperature (normal operating) <sup>(3)</sup>	-25	-	+55	°C					
T <sub>AO</sub>	Temperature (optimal operating) <sup>(4)</sup>	+5	-	+40	°C					
T <sub>AT</sub>	Temperature (test) <sup>(5)</sup>	+21	-	+25	°C					

Table 49. Operating conditions

1. Device has no permanent degradation.

2. Device is electrically functional.

3. Device produces 'acceptable' images.

4. Device produces optimal optical performance.

5. 100% tested parameters are measured at this temperature.

# 7.3 DC electrical characteristics

In this section, typical values are quoted for nominal voltage, process and temperature and maximum values are quoted for worst case conditions (process, voltage and functional temperature) unless otherwise specified.

### 7.3.1 Power supply - VDIG, VANA, VBAT

Table	50. Power supply -	VDIG, VANA, VBAT	

Parameter	Di	gital	An	Analog VCM		Unit
raiametei	Typical	Max	Typical	Max	Max	Offic
Hardware standby	8	45	7	35	8	μΑ
5.0 Mpixel 4:3 streaming <sup>(1)</sup> :	42	80	65	90	125 <sup>(2)</sup>	mA

1. Profile 0, 30 fps, CSI-2 dual lane, 10-10 data, 9.6 MHz external clock.

2. Worst case driver condition 0mA to 100mA output transition


### 7.3.2 CCI interface

Table	51.	CCI	interface

Symbol	Parameter	Minimum	Maximum	Unit
V <sub>IL</sub>	Low level input voltage	-0.5	0.3*VDIG	V
V <sub>IH</sub>	High level input voltage	0.7*VDIG	VDIG+0.5	V
V <sub>OL</sub>	Low level output voltage <sup>(1)</sup>	0	0.2*VDIG	V
V <sub>OH</sub>	High level output voltage	0.8*VDIG	VDIG	V
IIL	Low level input current	-	-10	μA
I <sub>IH</sub>	High level input current	-	10	μA

1. 3 mA sink current.

## 7.4 AC electrical and timing characteristics

In this section, typical values are quoted for nominal voltage, process and temperature and maximum values are quoted for worst case conditions (process, voltage and functional temperature).

### 7.4.1 Power supply (peak current) - VDIG, VANA

The peak current (in-rush) consumption of the sensor module is defined as any current pulse >=  $10\mu$ s. The duty cycle of the peak to the low part of the current profile is 33% with a worst-case period of 500  $\mu$ s.

Parameter	Dig	jital	Ana	Unit	
Farameter	Typical	Maximum	Typical	Maximum	Onic
Boot clock peak current <sup>(1)</sup>	80	100	200	230	mA
Start streaming current <sup>(2)</sup>	80	100	200	210	mA
Stop streaming current <sup>(3)</sup>	80	105	100	140	mA

 This corresponds to the transient current when the module is powered up and the sensor is being set to SW\_Standby mode. Maximum value is given for maximum supply voltages and 70°C ambient temperature. Typical value is for 25°C ambient temperature and supply voltages set to nominal value.

2. When the sensor is changed from software standby to streaming mode. Maximum value is given for maximum supply voltages and 70°C ambient temperature. Typical value is for 25°C ambient temperature and supply voltages set to nominal value.

 When the sensor is changed from streaming to software standby. Maximum value is given for maximum supply voltages and 70°C ambient temperature. Typical value is for 25°C ambient temperature and supply voltages set to nominal value.



## 7.4.2 System clock - EXTCLK

lable 53. System clock	Table 53	. Svstem	clock
------------------------	----------	----------	-------

Symbol	Parameter	Minimum	Maximum	Unit
V <sub>CL</sub>	DC coupled square wave low level	-0.5	0.3*VDIG	V
V <sub>CH</sub>	DC coupled square wave high level	0.7*VDIG	VDIG+0.5	V
f <sub>EXTCLK</sub>	Clock frequency input	6.0 - 1% <sup>(1)</sup>	27 + 1% <sup>(1)</sup>	MHz

1. Nominal frequencies are 6.0 to 27 MHz with a 1% centre frequency tolerance.

### 7.4.3 EXTCLK - timing characteristics

### Table 54. External clock timing characteristics

Symbol	Parameter	Minimum	Maximum	Unit
T <sub>jitter</sub>	Input clock jitter	-	100	ps

### Figure 24. External clock timing



### 7.4.4 CCI interface - timing characteristics

### Table 55. CCI interface timing characteristics

Symbol	Parameter	Parameter Minimum		Unit
t <sub>SCL</sub>	SCL clock frequency	0	400	kHz
t <sub>LOW</sub>	Clock pulse width low	1.3	-	μs
t <sub>HIGH</sub>	Clock pulse width high	0.6	-	μs
t <sub>BUF</sub>	Bus free time between transmissions	1.3	-	μs
t <sub>HD.STA</sub>	Start hold time	0.6	-	μs
t <sub>SU.STA</sub>	Start set-up time	0.6	-	μs
t <sub>HD.DAT</sub>	Data in hold time	0	0.9	μs
t <sub>SU.DAT</sub>	Data in set-up time	100	-	ns
t <sub>R</sub>	SCL/SDA rise time	20+0.1 C <sub>b</sub> <sup>(1)</sup>	300	ns
t <sub>F</sub>	SCL/SDA fall time	20+0.1 C <sub>b</sub> <sup>(1)</sup>	300	ns
t <sub>SU.STO</sub>	Stop set-up time	0.6	-	μs

Symbol	Parameter	Minimum	Maximum	Unit
Ci/o	Input/output capacitance (SDA)	-	8	pF
Cin	Input capacitance (SCL)	-	6	pF

 Table 55. CCI interface timing characteristics (continued)

1. Cb = total capacitance of one bus line in pF

Figure	25.	CCI	AC	characteristics
inguic	20.	001	70	01101 00101 101100



All timings are measured from either 0.1 VDIG or 0.9 VDIG.

For further information on the CCI interface, refer to the following specification documents: MIPI Alliance Standard for Camera Serial Interface 2 (CSI-2).

### 7.4.5 CSI interface - DATA+, DATA-, CLK+, CLK-

### Table 56. CSI interface - DATA+, DATA-, CLK+, CLK- characteristics

Symbol	Parameter	Minimum	Typical	Maximum	Unit
V <sub>OD</sub>	HS transmit differential voltage <sup>(1)</sup>	140	200	270	mV
V <sub>CMTX</sub>	HS transmit static common mode voltage	150	200	250	mV
Z <sub>OS</sub>	Single ended output impedance	40	50	62.5	Ω
t <sub>r</sub> and t <sub>f</sub>	20% to 80% rise time and fall time	150		0.3UI <sup>(2)</sup>	ps

1. Value when driving into load impedance anywhere in the  $Z_{\text{ID}}$  range (80 to 125 $\Omega$ ).

2. UI is equal to 1/(2\*fh) where fh is the fundamental frequency of the transmission for a certain bit rate. For example, for 600 Mbps fh is 300 MHz.

Note: For further information on the D-PHY, refer to the following specification document: MIPI Alliance Standard for D\_PHY.



# 8 Optical specification

## 8.1 Lens characteristics

### Table 57. Lens design characteristics for first source lens supplier

Parameter	Value					
Construction	4-elemer	nt plastic l	ens			
F/number	2.4					
Effective focal length	2.99 mm (primary wavelength 530 nm used)					
Diagonal FOV	74° +/- 1°					
Closest focusing distance	100 mm					
Distortion	TV: < 2%  Absolute: < 1.0%  across whole field (by design)					
Relative illumination (lens only)	40% at full image height, typical design value					
Spectral weighting:						
Wavlength (nm) Weight	656.28 151	587.56 318	546.07 312	486.13 157	435.84 49	404.66 13
Lateral chromatic aberration from 435 nm to 656 nm	<2.8um					
Coating reflectance - All surfaces are coated.	<1%					
Maximum chief ray angle	29°					
IR coating filter cut-off wavelength	650 nm -	⊦/-10 nm				

# 8.2 User precaution

As is common with many CMOS imagers, the camera should not be pointed at bright static objects for long periods of time as permanent damage to the sensor may occur.



# 9 Autofocus

This chapter is intended to give an overview of the control layer for the VB6955CM autofocus (AF) actuator and explain how to control the lens position.

The VB6955CM autofocus camera module contains the following AF components:

- lens
- voice-coil motor (VCM) actuator
- actuator driver
- NVM (on VB6955 silicon)



### Figure 26. Host and VB6955CM module system overview

### 9.1 VCM actuator

The voice-coil motor operates with a coil suspended in a magnetic field just as in a loudspeaker. A current is passed through the coil to displace the coil in the magnetic field. By design the displacement is linear with the current passed through the coil (in linear mode). The amount of current passed though the coil is controlled from an on-board DAC and actuator driver.

A diagram showing the typical displacement versus the DAC control is given in Figure 27.





Figure 27. Typical plot of displacement versus DAC control

For mechanical stability and precision the lens is pressed against its zero position with a spring. Therefore a certain force (current) and thus DAC code must be applied before a displacement takes place. Beyond this so called start current the VCM moves proportional to the applied current/DAC code.

The maximum displacement is defined by a stop position which is reached before the maximum excitation DAC code is reached. The linear stroke/DAC code relationship between the zero and the stop positions is exploited to deliver a repeatable positioning of the lens without need of a separate position sensor.

#### 9.2 VCM driver/DAC

The VCM driver in this camera module is an Analog Devices AD5816D. Details of how to control it can be found in the associated datasheet.

A few bytes of calibration data will need to be loaded into the driver IC during initialization.

#### 9.2.1 VCM driver control

The VCM driver registers are accessed through an I<sup>2</sup>C interface. However in normal operation the user will not need to access these registers directly. All autofocus operations are controlled by the high level autofocus control registers, see Section 4.2.17.

#### 9.2.2 VCM driver register access

It may be necessary to setup certain parameters in the VCM driver IC in order to match the characteristics of the mechanical VCM to obtain optimum performance. If this is required then the VCM driver registers may be accessed using the data transfer registers, see Section 4.2.14.



# 9.3 Examples

Contact ST for the latest application notes regarding reading the NVM and autofocus configuration.

## 9.4 Specification

Note: All parameters include the total moving mass.

Parame	eter	Minimum	Target	Maximum	Unit	Notes
Voltage range (Ad Voltage range (su	ctuator) ipply)	1.5 2.5		4.4 4.8	V V	Actuator voltage VBAT supply
Rated current				80	mA	Macro focus current under worst case orientation and temperature conditions in linear drive mode
Posistanco	at 70°C	12.6	13.8	15	ohm	Retwoon VCM terminal
Resistance	at -30°C	9.1	10	10.9	ohm	
Insulation resistar	nce	1M			ohm	Resistance of terminal to ground (shield) with 40V.
Rated stroke		150			micron	Stroke at 80 mA
Full stroke		200			micron	Maximum stroke
	Upward	20	30	40	mA	Based upon sensitivity
Starting current	Downward	10	20	30	mA	calculated between 0-150um
	Horizontal	15	25	35	mA	stroke
Linearity				10	micron	Deviation from ideal line calculated between 0 - 150 micron stroke
Starting displacen	nent			12	micron	Stroke at starting current position
Sensitivity		4.0		8.0	micron/mA	Based upon ideal line calculated between 0-150um stroke
Reproducibility			<2		um	For a 20um step away from and back to original position
Posture depende	ncy	24	32	40	micron	Lens gravitational deviation from horizontal orientation
Hysteresis				10	micron	Measured between 0-150um stroke
Force generation	efficiency	0.29	0.51	0.96	mN/mW	includes magnet and coil resistance spreads
Spring force prelo	ad	5.1	5.6	6.2	mN	

Table 58	Autofocus	specification -	Tvne M
Table Ju	- Autorocus	specification -	iype w



Parame	ter	Minimum	Target	Maximum	Unit	Notes
Force at macro		9.0	9.9	10.8	mN	
Hold power	Infinity	20		50	mW	Including DW/M driver
Hold power	Maximum	50		100	mW	
Spring constant		30	33	36	mN/mm	
Primary resonance (including total me	e frequency oving mass)		93		Hz	
Settling time				15	mS	When displacement larger than 100 micron and settling to +/- 3 micron
Total moving mas	S			0.12	g	
Tilt (dynamic) (not optical)				0.15	degrees	Tilt of lens holder at "Rated Stroke" minus the tilt when unpowered condition
Tilt (static) (not optical)				0.1	degrees	Maximum tilt of lens holder when unpowered
Total tilt (not optical)				0.2	degrees	dynamic and static combined
Barrel torque	focusing			80	gfcm	Torque needed to focus the barrel in the focusing stage of final assembly
	breaking	120			gfcm	Torque needed to unlock the barrel after gluing
Mechanical shock start current chan	k induced ge			7.5	%	Start current pre/post mechanical shock.
Mechanical shock sensitivity change	k induced			15	%	Sensitivity pre/post mechanical shock.
Infinity search tim	е			0.2	S	
Speed		3			mm/S	Including settling inside +/- 3 micron target
AF step movemen	nt time			20	mS	Includes settling time limit.
Audible noise leve	el			30	dB	
Actuator step reso	olution			2	micron	

Table 58. Autofocus specification - Type M (continued)



Parame	ter	Minimum	Target	Maximum	Unit	Notes
Voltage range (Ac	tuator)	1.5		4.4	V	Actuator voltage
Voltage range (su	pply)	2.5		4.8	V	VBAT supply
Rated current				80	mA	Macro focus current under worst case orientation and temperature conditions in linear drive mode
Resistance	at 70°C	17.6	19.4	21.3	ohm	Between VCM terminal
Resistance	at -30°C	11.3	12.6	13.8	ohm	
Insulation resistar	ice	1M			ohm	Resistance of terminal to ground (shield) with 40V.
Rated stroke		150			micron	Stroke at 80 mA
Full stroke		200			micron	Maximum stroke
	Upward	20	30	40	mA	Based upon sensitivity
Starting current	Downward	10	20	30	mA	calculated between 0-150um
	Horizontal	15	25	35	mA	stroke
Linearity				10	micron	Deviation from ideal line calculated between 0 - 150 micron stroke
Starting displacem	nent			12	micron	Stroke at starting current position
Sensitivity		4.0		8.0	micron/mA	Based upon ideal line calculated between 0-150um stroke
Reproducibility			<2		um	For a 20um step away from and back to original position
Posture depender	тсу	30	40	50	micron	Lens gravitational deviation from horizontal orientation
Hysteresis				10	micron	Measured between 0-150um stroke
Force generation	efficiency	0.29	0.51	0.96	mN/mW	includes magnet and coil resistance spreads
Spring force prelo	ad	5.2	5.8	6.3	mN	
Force at macro		10.4	11.6	12.6	mN	
Hold power	Infinity	30		75	mW	Including DW/M driver
riold power	Maximum	75		150	mW	
Spring constant	-	35	39	43	mN/mm	
Primary resonanc (including total mo	e frequency oving mass)		100		Hz	
Settling time				15	mS	When displacement larger than 100 micron and settling to +/- 3 micron

### Table 59. Autofocus specification - Type L



Parame	ter	Minimum	Target	Maximum	Unit	Notes
Total moving mas	S			0.12	g	
Tilt (dynamic) (not optical)				0.15	degrees	Tilt of lens holder at "Rated Stroke" minus the tilt when unpowered condition
Tilt (static) (not optical)				0.1	degrees	Maximum tilt of lens holder when unpowered
Total tilt (not optical)				0.2	degrees	dynamic and static combined
Barrel torque	focusing			80	gfcm	Torque needed to focus the barrel in the focusing stage of final assembly
	breaking	120			gfcm	Torque needed to unlock the barrel after gluing
Mechanical shock start current chan	induced ge			7.5	%	Start current pre/post mechanical shock.
Mechanical shock sensitivity change	k induced			15	%	Sensitivity pre/post mechanical shock.
Infinity search tim	е			0.2	S	
Speed		3			mm/S	Including settling inside +/- 3 micron target
AF step movemer	nt time			20	mS	Includes settling time limit.
Audible noise leve	el			30	dB	
Actuator step rese	olution			2	micron	

### Table 59. Autofocus specification - Type L (continued)



# 10 Non-volatile memory (NVM)

A summary of the NVM register map is shown in Table 60.

	Byte	Segment
	0 to 5	NVM configuration
	6 to 264	Lens shading data (illuminant 1 - 5300K)
Host payload	265 to 520	Lens shading data (illuminant 2 - 2800K)
l lost payloau	521 to 534	Auto focus data
	535 to 537	Error checking
	538 to 539	Empty (padding)
ST	540 to 901	ST test payload
ST firmware payload	902 to 1023	ST firmware



# 11 Defect categorization

### 11.1 Pixel defects

### 11.1.1 Overview

*Pixel defect density* measures the average number of defective pixels per color channel under "Diffuse" and "Dark" conditions, refer to *Table 61*.

	Reference Area	Threshold
Dark	Full Channel	64 codes
Light	9x9	+/-12%

Table 61. Pixel	defect s	specification
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### 11.1.2 Defect detection

Defect detection is performed in two parts; once in diffuse conditions and once in dark conditions, as defined in *Table 61*. The methods used for these differ to account for the differing conditions and for the difference in the failure modes detected by each.

	<u> </u>	
	Dark	Diffuse
Exposure	100ms	33ms <sup>(1)</sup>
Analog gain	x8	x1
Digital gain	x1	x1

Table	62.	Image	setting	qs
				_

1. Image exposure targets 75% of full-scale deflection in the green channels at the centre of the image.

In both the dark and light cases, two images are averaged pixel-by-pixel in order to reduce the impact of temporal noise. Detection is performed individually on the four colour channels.

"Dark defects" are those which appear too bright in a dark image, either due to dark current or a stuck-at fault. These are measured by thresholding against the difference between the actual pixel value and the local or full-frame average (this is dependent on the uniformity of the dark image). The threshold is defined such that it can identify gain error above the normal noise distribution of photon shot noise and sensor noise and so pixels that deviate by more than the dark threshold are declared defective.

"Light defects" tend to be caused by small foreign material or damage to the die surface. The diffused image is processed to remove very low frequency variation by gaining the image towards the centre peak value for each colour channel, mimicking the lens shading gains applied in the application. Pixels that deviate from the local average by more than the light threshold in either direction are defined as defective. The 64-code pedestal is not removed from this relative calculation.



#### 11.1.3 **Defect categorisation: Single pixels**

Figure 28. shows the numbering of the neighboring pixels in a 3x3 grid within a single color channel; all the pixels will either be red, green-red, green-blue or blue. The pixel under test is X. If a pixel under test is on the edge on the image, the array is reduced to its existing neighbor pixels (i.e. the top-left pixel uses only a 2x2 array).

[0]	[1]	[2]
[7]	Х	[3]
[6]	[5]	[4]

Figure 28.	Pixel	numbering	notation
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A single pixel fail is defined as a failing pixel with no adjacent failing pixels in the neighboring pixels 0 to 7. A single pixel fail can be a stuck at white, where the output of the pixel is permanently saturated regardless of the level of incident light and exposure level, a stuck at black where the pixel output is zero regardless of the level of incident light and exposure level (major fail) or simply a pixel that differs from its immediate neighbors by more than the test threshold (minor fail).

In the example in Figure 29, shown, we assume that pixel X is a failing pixel. For this pixel to be categorised as a single pixel fail, the pixels at positions [0], [1], [2], [3], [4], [5], [6] and [7] must be "good" pixels that pass final test. The test program will pass a sensor with up to the defined limit of single pixel faults per colour channel.

### Figure 29. Single pixel fault

[0] [1]	[2]
[7] X	[3]
[6] [5]	[4]

#### 11.1.4 Defect categorisation: Couplets

A couplet is formed by a failing pixel at X neighboring a failing pixel at position [0] or [1] or [2] or [3] or [4] or [5] or [6] or [7], such that there is a maximum of 2 failing pixels from the group of 9 pixels. The example shown in Figure 30 has the centre pixel and the pixel at position [7] failing the test criteria.

[6] [5] [4]

This product has on-chip mapped couplet correction capable of storing up to 14 defect locations. No unmapped couplets are allowed in a full resolution image.

#### 11.1.5 **Defect categorisation: Clusters and blobs**

If pixel X is a failure and between 2 and 7 of the surrounding pixels are also defective, then the pixels are categorised as a cluster. If all nine pixels are defective then the failure is classified as a blob. Neither clusters nor blobs are allowed.



## 11.2 Blemishes

### 11.2.1 Blemish overview

A specific test algorithm is applied in production to identify and reject samples that display defocussed artefacts often referred to as blemishes or shapes. These artefacts are caused by scratches or contamination in the optical path away from the focal plane, i.e. on the IR glass or lens. The principal idea behind the test is to band-pass filter the image to remove very low frequency lens shading and very high frequency noise and pixel defectivity. The residual non-uniformity of the frame is at a frequency the shows the mark in the image. This test is performed independently on each of the four colour channels.

### 11.2.2 Blemish algorithm

The diffuse image is first flattened using a combination of model-based lens shading correction and very low pass filtering using convolution. In both cases, the pixels values are gained towards the pixel values at the image centre, which results in amplification of errors in far field, similar to the application condition.

The resulting image is then passed through a gross defect-correction algorithm to remove extreme errors, which result in notable residual error even in a smoothed frame.

The blemish test itself uses band-pass filtering, implemented by convolving the preprocessed image using two "flat" kernels (kernels where all positions are given an equal value and the result is normalised to the sum, resulting in a local averaging effect).

The test requires two kernels to be defined:

 $k_{small}$ : A square kernel defined to remove artefacts smaller than the target size, 9x9 pixels in the following example.

 $k_{large}$ :A second square kernel, much larger and defined to remove artefacts and shading larger than the target size, 31x31 pixels in the following example.





The local mean for each kernel is calculated for every pixel in the input frame. When a kernel overlaps the edge of the frame (in the border regions), every missing pixel outside the



frame boundary is compensated by the removal of a pixel on the inside, maintaining a symmetrical kernel at all times. This avoids the amplification of non-uniformities at the edge and can reduce the need to exclude image borders from the test.



Figure 32. Scan array for blemish

The two convolved images are compared against a threshold relative to the localised average from the larger kernel. Each pixel that deviates by more than a chosen threshold (positive or negative) is marked as a defective pixel in a fail map: See *Figure 33*.

- Small\_average < Large\_average (Threshold x Large\_average) or
- Small\_average > Large\_average + (Threshold x Large\_average)



Figure 33. Fail map



At this point, a border may be removed from the failmap in order to remove convolution related and border related errors. This can also allow for a two pass test that does not exclude the border, but does apply a relaxed specification.

The failmaps are scanned by a seed-fill algorithm to determine the size of the largest contiguous area.

Areas smaller than, or close to the size of the small kernel can be caused by single pixel and couplet defects, so a threshold is applied to the minimum shape size. The result is recorded as a pass or a fail.

If more than one blemish type test is put in place then any failing iteration results in rejection of the device under test.







# 12 On-chip image optimization

## **12.1** Mapped couplet correction (Bruce filter)

The mapped couplet defect correction filter is designed to intelligently correct the first defect in a couplet thereby changing a couplet into a single pixel defect. Single pixel correction is achieved by the host (coprocessor, MMP or baseband). The mapped couplet correction filter only operates in full resolution mode.

The mapped couplet correction filter requires exact coordinate information for each of the couplets to be repaired. The couplet coordinates are stored in non-volatile-memory (NVM) during production test.



# 13 Mechanical









Figure 36. VB6955CM outline drawing in mm - sheet 1 of 6





Figure 37. VB6955CM outline drawing in mm - sheet 2 of 6





Figure 38. VB6955CM outline drawing in mm - sheet 3 of 6

Figure 39. VB6955CM outline drawing in mm - sheet 4 of 6











Figure 41. VB6955CM outline drawing in mm - sheet 6 of 6



# 14 Application

## 14.1 Schematic



Figure 42. Mobile camera application



# 15 Acronyms and abbreviations

Acronym/ abbreviation	Definition	
CCI	Camera control interface	
СМІ	Camera module integrator	
CSI	Camera serial interface	
DPCM	Differential pulse code modulation	
EMC	Electromagnetic compatibility	
EMI	Electromagnetic interference	
EOF	End of frame	
EOT	End of transmission	
FE	Frame end	
fps	Frames per second	
FS	Frame start	
HS	High speed; identifier for operation mode	
HS-RX	High speed receiver (low-swing differential)	
HS-TX	High speed transmitter (low-swing differential)	
l <sup>2</sup> C	Inter ICbus	
LE	Line end	
LLP	Low level protocol	
LS	Line start	
LSB	Least significant byte	
LP	Low power; identifier for operation mode	
LP-RX	Low power receiver (large-swing single ended)	
LP-TX	Low power transmitter (large-swing single ended)	
LVDS	Low voltage differential signaling	
Mbps	Megabits per second	
MIPI	Mobile industry processor interface	
MSB	Most significant byte	
PCK	Pixel clock	
PCM	Pulse code modulation	
PF	Packet footer	
PH	Packet header	
PI	Packet identifier	
PT	Packet type	



Acronym/ abbreviation	Definition	
PHY	Physical layer	
PLL	Phase locked loop	
RO	Read only	
RW	Read/write	
SCL	Serial clock (for CCI)	
SDA	Serial data (for CCI)	
SMIA	Standard mobile imaging architecture	
SOT	Start of transmission	
SOF	Start of frame	
SSCG	Spread spectrum clock generator	
SubLVDS	Sub-low voltage differential signaling	
WDR	Wide dynamic reconstructor	
ULPM	Ultra low power mode	

Table 63. Acronyms and abbreviations (continued)



# 16 ECOPACK<sup>®</sup>

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# 17 Revision history

Table	64.	Document	revision	history
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Date	Revision	Changes
22-Oct-2015	1	Initial release



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